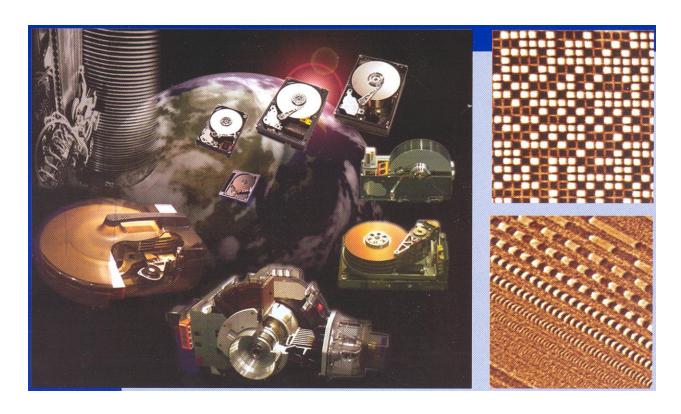
## Magnetic Recording



Stella Z. Wu







IEEE Magnetics Society Summer School Rio, August 10-15, 2014

## Acknowledgement

Jan-Ulrich Thiele

**Roger Wood** 

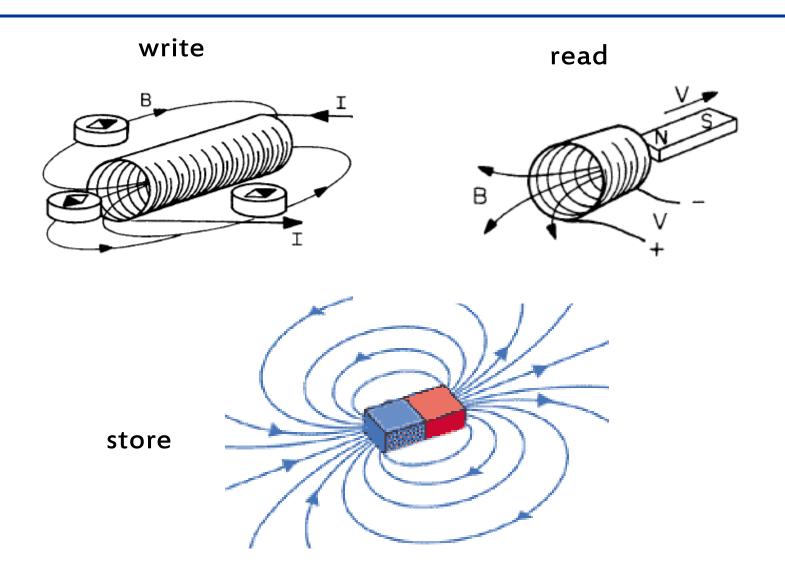
**Kaizhong Gao** 

**Ganping Ju** 

**Shuaigang Xiao** 

And many more of my Seagate colleagues

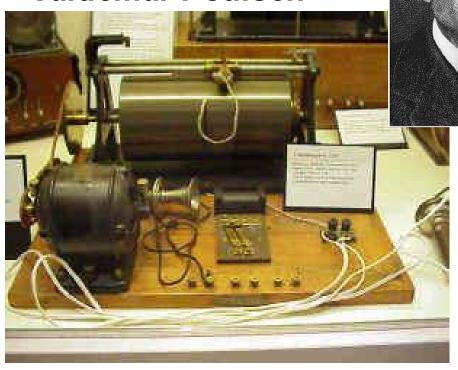
## Elements of a magnetic recording system



## 116 years ago

## Magnetic Recording Invented

Valdemar Poulsen

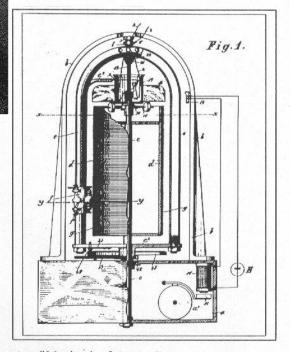


Valdemar Poulsen's wire recorder from 1898 (Danish technical museum www.tekniskmuseum.dk)

1898

MAGNETIC RECORDING

Invented by Valdemar Poulsen Copenhagen, Denmark 1898



"Method of Recording and Reproducing Sounds or Signals."

## 58 years ago

1956 5 MegaBytes Fifty 24" disks 1200 RPM 2 kbits/sq.in. " 100 BPI x 20 TPI ZBR 388 RAMAC " 150 kbit/s

IBM RAMAC - first HDD

\$10,000/Mbyte

#### Enterprise Capacity 3.5 HDD



Now

From 5MB to 5TB: x1,000,000 capacity increase!!

Considerations	12Gb/e SAS				
Specifications	6TB <sup>1,2</sup>	5TB <sup>1,2</sup>	4TB <sup>4,2</sup>	2TB <sup>1</sup>	
Standard Model Number (4KN)	ST6000NM0014	_	_	_	
Standard Model Number (512E)	ST6000NM0034	ST5000NM0034	ST4000NM0034	ST2000NM0034	
SED Model Number (512E)	ST6000NM0054°	ST5000NM0054 <sup>2</sup>	ST4000NM0054°	ST2000NM0054	
SED-FIPS Model Number (512E)	ST6000NM010424	_	_	_	
eatures					
Protection Information (T10 DIF)	Yes	Yes	Yes	Yes	
Humidity Sensor	Yes	4.4	1.4	ы	
Super Parity	Yes				
ow Halogen	Yes		136		
PowerChoice Technology	Yes		The state of the s		
Cache, Multisegmented (MB)	128		// •	- Am	
Reliability/Data Integrity			Seagate C	10	
Mean Time Between Failures (MTBF, hours)	1.4M	4	( )		
Reliability Rating @ Full 24x7 Operation (AFR)	0.63%	/2	) j		
Vonrecoverable Read Errors per Bits Read	1 sector per 10E15		Of Control		
ower-On Hours per Year	8760 (24x7)		rise Capacia,	16	
Sector Size (Bytes per Logical Sector)	512/4096		1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	110	
imited Warranty (years)	5		章宝 自然的		
Performance			見る とは 一	9///	
Spindle Speed (RPM)	7200	4	seagate	////	
nterface Access Speed (Gb/s)	12.0, 6.0, 3.0		6TB		
Max. Sustained Transfer Rate OD (MB/s)	up to 226		10		
werage Latency (ms)	4.16			)	
nterface Ports	Dual		A	10	
Rotation Vibration @ 1500 Hz (rad/s²)	12.5				
ower Consumption					
				mic district	
die Power, Average (W)	7.97				
	7.97 11.86				
Typical Operating, Random Read (W)	1.21				
Typical Operating, Random Read (W) Power Supply Requirements	11.86			7	
ypical Operating, Random Read (W) Power Supply Requirements Environmental	11.86	5 to 60	5 to 60	5 to 60	
Typical Operating, Random Read (W) Power Supply Requirements Environmental Temperature, Operating (°C)	11.86 +12V and +5V	5 to 60 4.9	5 to 60 4.9	5 to 60 4.9	
Typical Operating, Random Read (W)  Power Supply Requirements  Environmental  Femperature, Operating (°C)  //ibration, Nonoperating: 10Hz to 500Hz (Grms)	11.86 +12V and +5V 5 to 60				
Typical Operating, Random Read (W) Power Supply Requirements Environmental Femperature, Operating (°C) Fibration, Nonoperating: 10Hz to 500Hz (Grms) Shock, Operating, 2ms (Read/Write) (Gs)	11.86 +12V and +5V 5 to 60 4.9	4.9	4.9	4.9	
ypical Operating, Random Read (W)  Yower Supply Requirements  Environmental  Gemperature, Operating (°C)  Fibration, Nonoperating: 10Hz to 500Hz (Grms)  Shock, Operating, 2ms (Read/Write) (Gs)  Shock, Nonoperating, 1ms and 2ms (Gs)	11.86 +12V and +5V 5 to 60 4.9 70/40	4.9 70/40	4.9 70/40	4.9 70/40	
ypical Operating, Random Read (W)  Yower Supply Requirements  Environmental  Gemperature, Operating (°C)  Fibration, Nonoperating: 10Hz to 500Hz (Grms)  Shock, Operating, 2ms (Read/Write) (Gs)  Shock, Nonoperating, 1ms and 2ms (Gs)	11.86 +12V and +5V 5 to 60 4.9 70/40	4.9 70/40	4.9 70/40	4.9 70/40	
Typical Operating, Random Read (W) Power Supply Requirements Environmental Temperature, Operating (°C) Tibration, Nonoperating: 10Hz to 500Hz (Grms) Shock, Operating, 2ms (Read/Write) (Gs) Shock, Nonoperating, 1ms and 2ms (Gs) Physical Height (in/mm, max) <sup>5</sup>	11.86 +12V and +5V 5 to 60 4.9 70/40 250	4.9 70/40 300	4.9 70/40 300	4.9 70/40 300	
Typical Operating, Random Read (W) Power Supply Requirements  Environmental  Femperature, Operating (°C)  Fibration, Nonoperating: 10Hz to 500Hz (Grms)  Shock, Operating, 2ms (Read/Write) (Gs)  Shock, Nonoperating, 1ms and 2ms (Gs)  Physical  Height (in/mm, max) <sup>2</sup> Width (in/mm, max) <sup>3</sup>	11.86 +12V and +5V 5 to 60 4.9 70/40 250	4.9 70/40 300 1.028/26.1	4.9 70/40 300 1.028/26.1	4.9 70/40 300 1.028/26.1	
Typical Operating, Random Read (W) Power Supply Requirements  Environmental  Femperature, Operating (°C)  Fibration, Nonoperating: 10Hz to 500Hz (Grms)  Shock, Operating, 2ms (Read/Write) (Gs)  Shock, Nonoperating, 1ms and 2ms (Gs)  Physical  Height (in/mm, max) <sup>3</sup> Depth (in/mm, max) <sup>3</sup>	11.86 +12V and +5V 5 to 60 4.9 70/40 250 1.028/26.1 4.010/101.85	4.9 70/40 300 1.028/26.1 4.010/101.85	4.9 70/40 300 1.028/26.1 4.010/101.85	4.9 70/40 300 1.028/26.1 4.010/101.85	
dle Power, Average (W) Typical Operating, Random Read (W) Power Supply Requirements  Environmental Temperature, Operating (°C) //ibration, Nonoperating: 10Hz to 500Hz (Grms) Shock, Operating, 2ms (Read/Write) (Gs) Shock, Nonoperating, 1ms and 2ms (Gs) Physical Height (in/mm, max)* Width (in/mm, max)* Depth (in/mm, max)* Weight (Ib/g) Carton Unit Quantity	11.86 +12V and +5V 5 to 60 4.9 70/40 250 1.028/26.1 4.010/101.85 5.878/147.0	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0	
Typical Operating, Random Read (W) Power Supply Requirements  Environmental  Temperature, Operating (°C)  Vibration, Nonoperating: 10Hz to 500Hz (Grms)  Shock, Operating, 2ms (Read/Write) (Gs)  Shock, Nonoperating, 1ms and 2ms (Gs)  Physical  Height (in/mm, max) <sup>2</sup> Depth (in/mm, max) <sup>3</sup> Weight (Ib/g)	11.86 +12V and +5V 5 to 60 4.9 70/40 250 1.028/26.1 4.010/101.85 5.878/147.0 1.720/780	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0 1.720/780	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0 1.400/635	4.9 70/40 300 1.028/26.1 4.010/101.85 5.878/147.0 1.344/605	

## Online Life Style







Facebook Data Center in Oregon

## Price scaling

```
1956 IBM RAMAC - first HDD: $10,000,000/GB
```

#### **Digital Storage Cost per GB 1981 – 2012**

```
$300,000
1981
          $50,000
1987
          $10,000
1990
          $1,000
1994
          $100
1997
          $10
2000
          $1
2004
2012
          $0.10
```

## **Timeline**

Sony walkman holds 90min of music	1979
Seagate ships 1st hard drive	1980
IBM launches 1st personal	
computer	1981
Time magazine names	
_	
computer: Machine of the Year	1982
Introduction of Microsoft	
Word	1983
AI	
Apple introduces the Macintosh	1984
Plackbuster apons 1st	
Blockbuster opens 1st store	1986

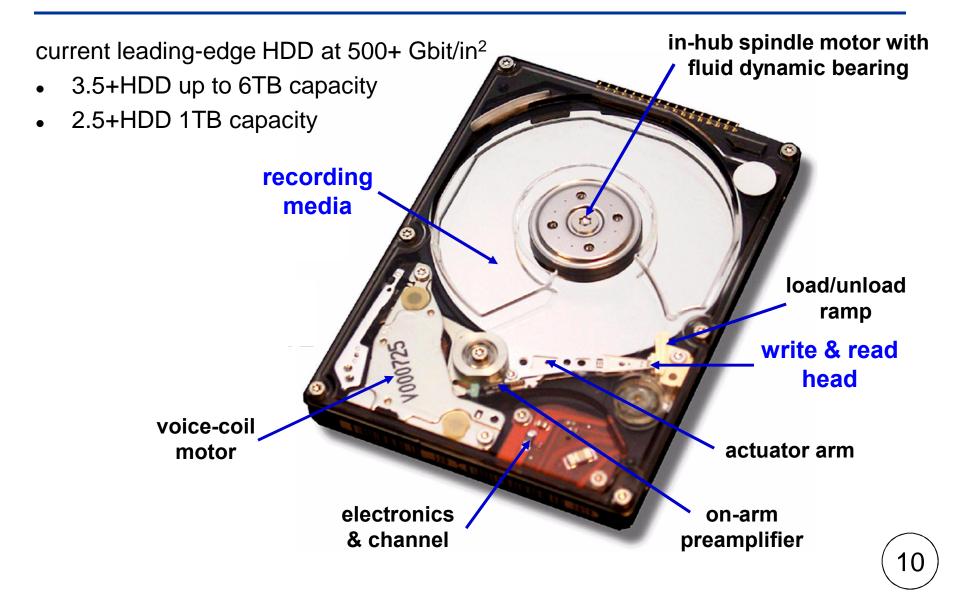
Seagate ships 5M hard drives	1988
WWW established with HTML	1990
Seagate ships 100M hard drives	1996
More emails than snail mails	
Xbox 360 unveiled w Seagate drive	2005
Seagate ships 1 billion hard drives	2008
World's largest data center opens in Nevada	
Seagate ships 2 billion hard drives	2013

It takes > 28 years to reach first billion hard drive shipment

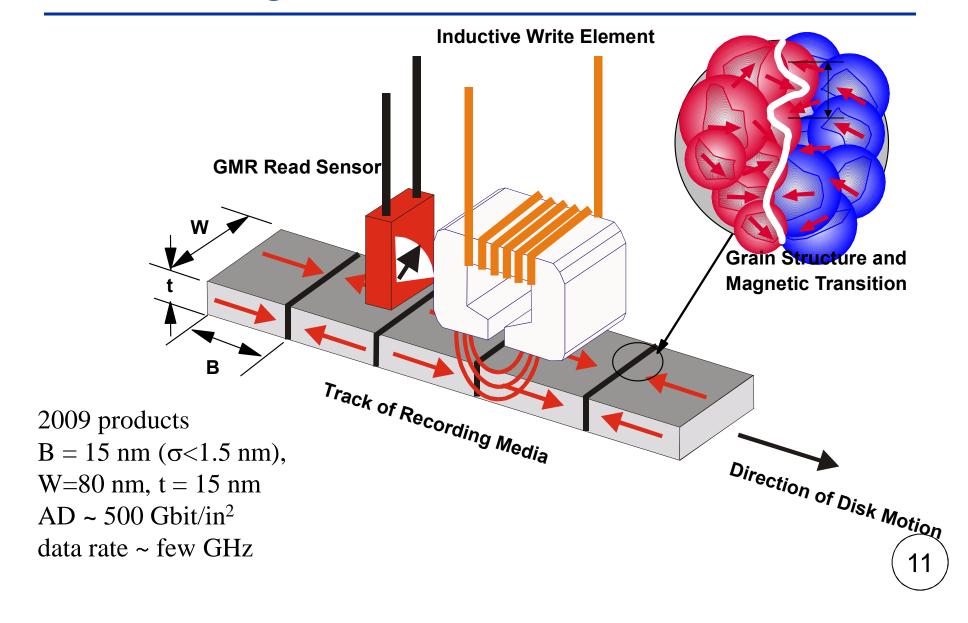
It takes only ~4 years to reach second billion hard drive shipment

(3/12/2013 Seagate press release)

## Components of a Hard Disk Drive



## Recording basics

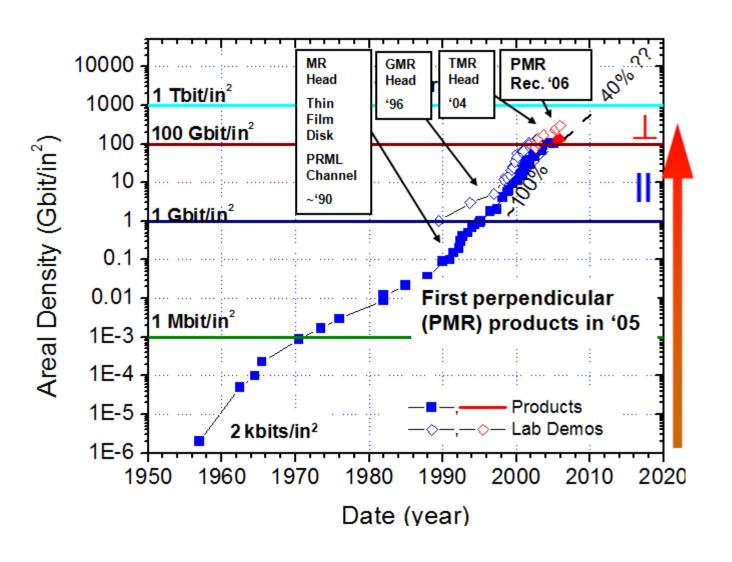


#### **HDD Industry Roadmap: Areal Density Growth**

Commercial product 720 Gbits/in<sup>2</sup>, 500 GB/2.5" Platter

Demonstration ~1 Tbits/in²

Research frontier 1.5-10 Tbits/in<sup>2</sup>

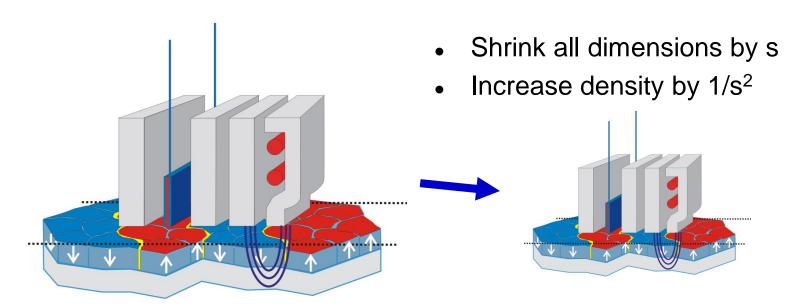




Technology
Options:
Longitudinal
Perpendicular
Heat Assist
Patterned Media

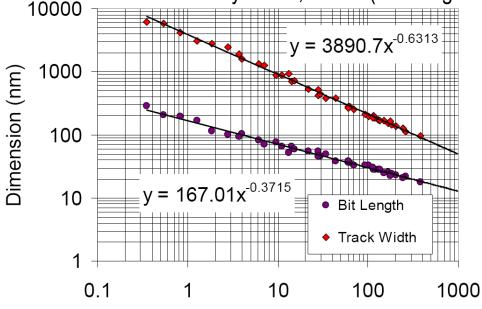
## Scaling

- Worked successfully for 50 years
  - Write head lithography/materials improved
  - Sensors improved Inductive ⇒ AMR ⇒ GMR ⇒ TMR ⇒ õ
  - Media with smaller more isolated grains
  - Fly height reduced from μm to ~10nm



#### CC-01: Magnetic Spacing Trends: From LMR to PMR and Beyond

Bruno Marchon and Terry Olson, HGST (Intermag 2009)

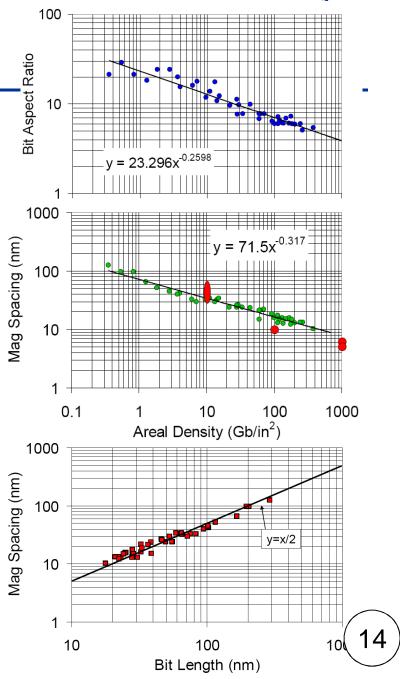


Areal Density (Gb/in<sup>2</sup>)

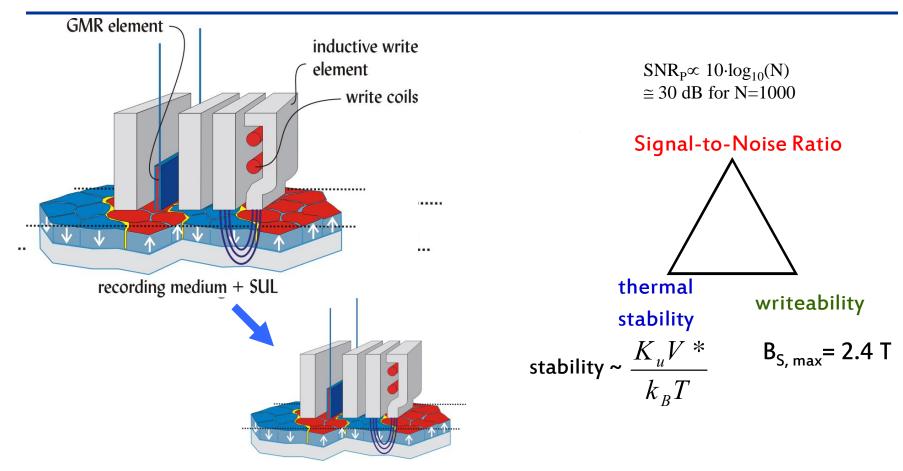
- The scaling trends have held from below 1Gb/in² until today's densities, with no significant discontinuities when crossing major technology changes.
- HMS scaling may be rationalized based on a readback argument.

$$\blacksquare HMS\% = 1 - (1 - AD\%)^{-0.32}$$

AD (Gbpsi)	1,000	2,000	10,000
HMS (nm)	8.0	6.4	3.9
BAR	3.9	3.3	2.1



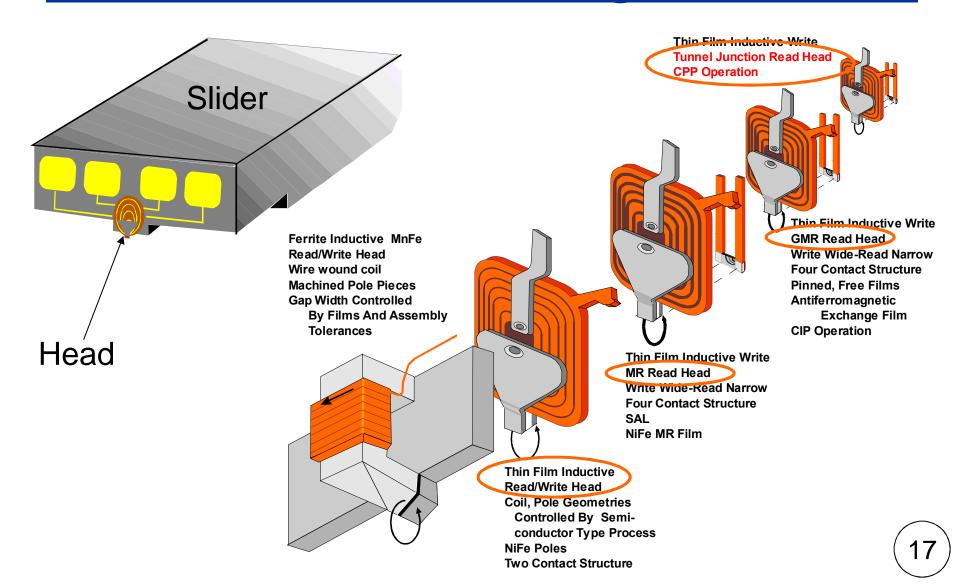
### Limits to £onventionalqscaling in magnetic recording



The achievable areal density using £onventionalqscaling is limited by trade-off between SNR, thermal stability and writeability

## Write Element

## **Evolution of Recording Heads**

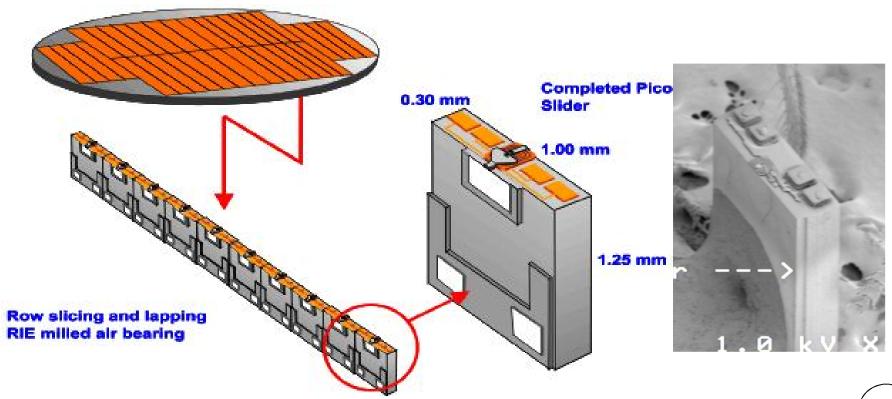


#### Thin Film Head Process. Wafer to Row to Slider

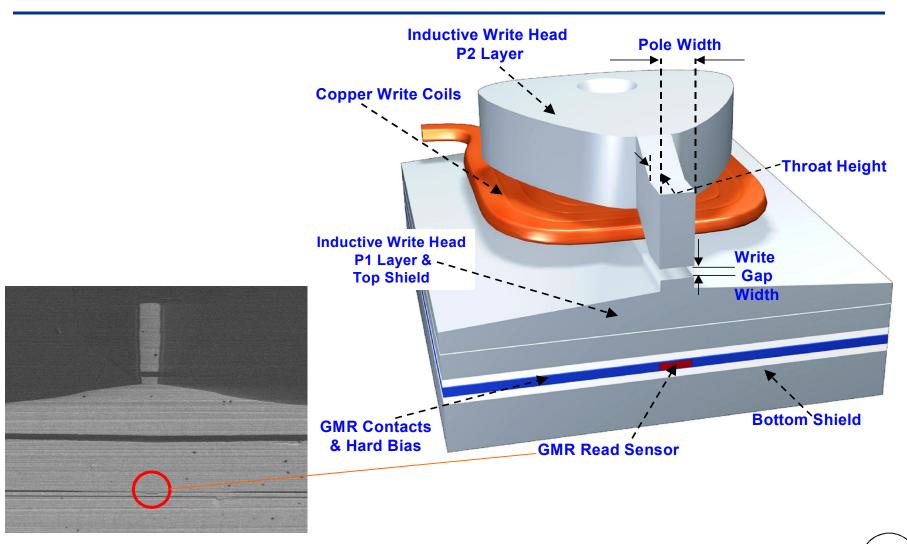
HEAD

É3 minimum features / mm² É10<sup>5</sup> features / 200 mm wafer IC

 $\acute{E}10^6 - 10^7 \text{ minimum features / mm}^2$   $\acute{E}10^{10} - 10^{11} \text{ features / 200 mm wafer}$ 



### Thin Film Recording Head (longitudinal)



## Scaling the write head

- resolution limited by lithography (and inability to continue scaling of fly height)
- maximum field limited by materials availability to ~2.4T

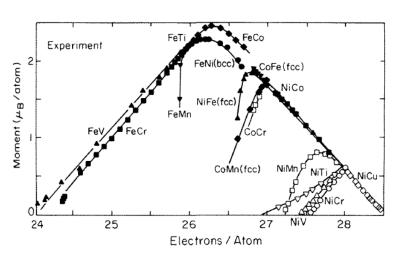
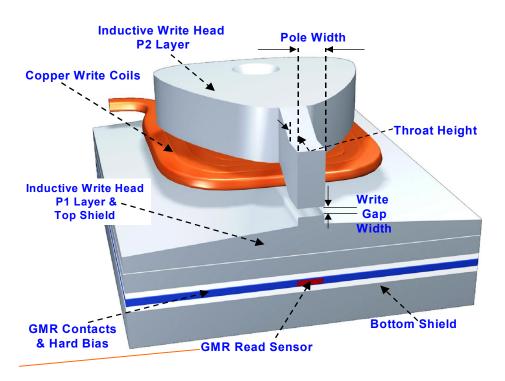
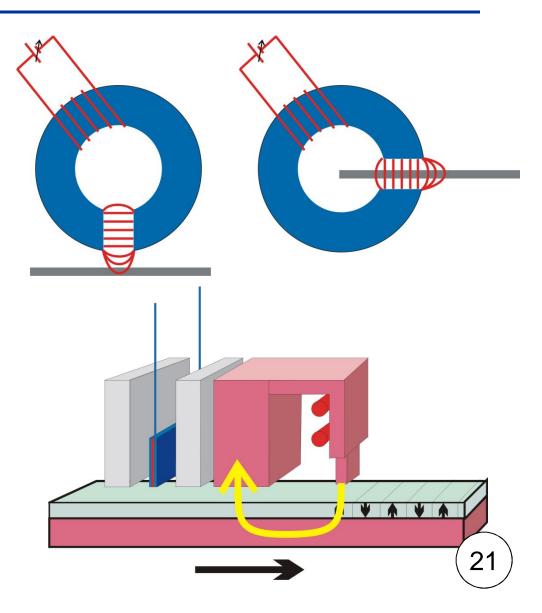


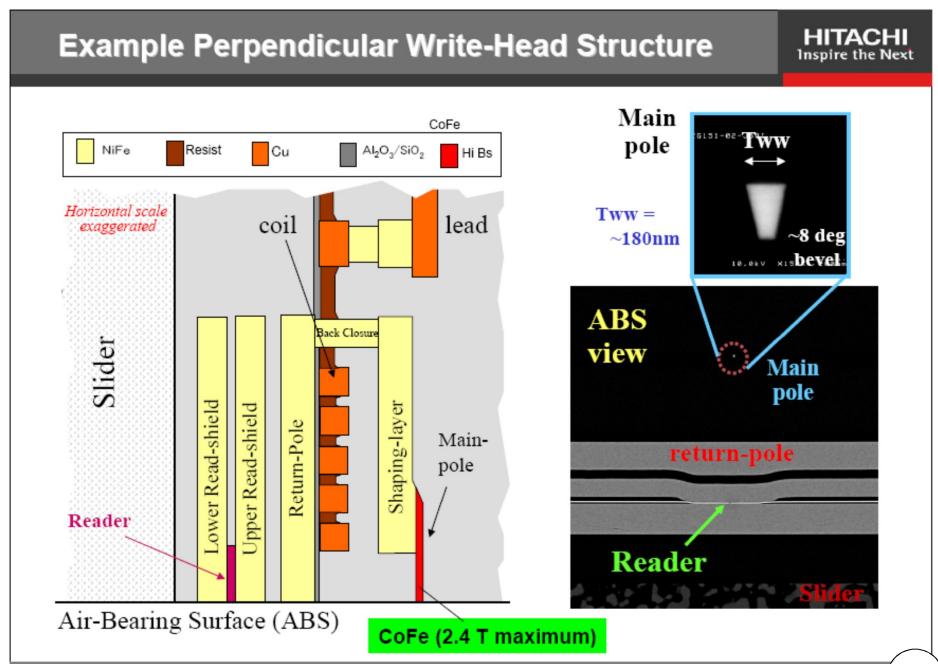
Figure 5.1 The Slater-Pauling curve showing moment per atom (in Bohr magnetons) for metallic alloys as a function of valence electron concentration or alloy composition. [After Dederichs et al. (1991).]



### Longitudinal & perpendicular recording

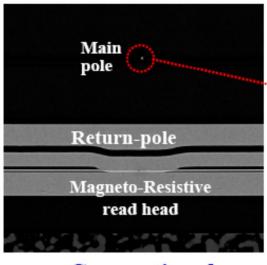
- In longitudinal recording bit transitions are written by the fringing fields, in perpendicular recording the media is directly in the magnetic circuit
- In principle this allows larger fields to be applied and sharper field gradients
- Ideally need to match the head and media soft underlayer (SUL)
- Single pole design means much thinner pole tips
- Easier to scale to narrow dimensions
- Max. B<sub>S</sub> of CoFe-alloy pole tip materials ~2.4T, however max. write field in the media ~ 1-1.2T

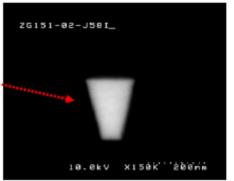


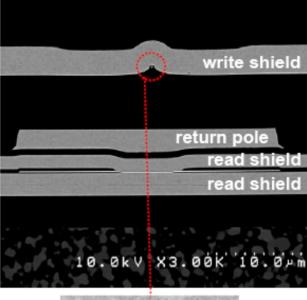


#### Shielded Write Head









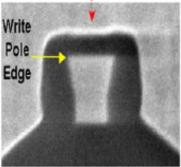
Conventional Trapezoidal Structure

(Field gradient:80-100 Oe/nm)

Trailing-Shield enhances write-field gradients

Side-shields confine side-writing fields and prevent adjacent track erasure (ATE)

(side leakage of fields can cause erasure of data on adjacent tracks, )



New Trailing & Side-Shield Structure (Field gradient: 150-200 Oe/nm)

## Read Sensor

#### **Progress in Read Head Sensor Technologies**



Year	Density (Gb/in²)	Sensor Technology	Structure	MR Effect	Current Geometry
1979	0.01 Gb/in <sup>2</sup>	Thin-film Inductive		N/A	N/A
1991	0.1 Gb/in <sup>2</sup>	MR Sensor	Lead NiFe Free Layer Layer Hard Bias Spacer NiFeX SAL Shield	Anisotropic MR	CIP
1997	2 Gb/in <sup>2</sup>	Spin Valve	Lead Hard Bias Cu Spacer NiFe Free Layer Shield	Giant MR	CIP
2006	100 Gb/in <sup>2</sup>	Tunnel Valve	Shield  CoFe/NiFe Free Layer  Spacer Hard Bias Insulator  MgO Tunnel Barrier  AP Pinned CoFeB Layer  Shield	Tunneling MR	СРР
2011	1 Tb/in <sup>2</sup>	CPP GMR	High spin-scattering Free Layer  Spacer Hard Bias Insulator  High spin-scattering Pinned Layer  Shield	Giant MR	СРР

#### 2007 Nobel prize

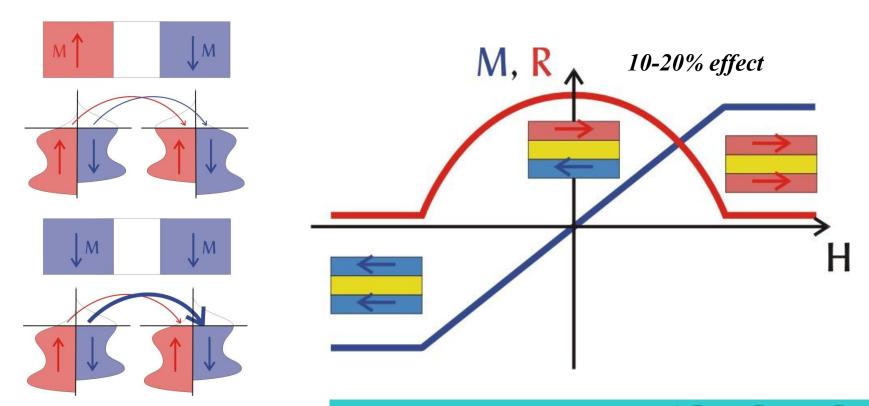




Albert Fert & Peter Grunberg

## Giant Magneto-resistance (GMR)

#### Julliere's two-current model $I = I_1 + I_2$

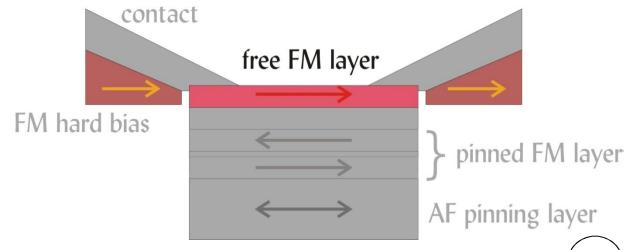


Baibich et al. Phys. Rev. Lett. **61** 2472 (1988) Binasch et al. Phys. Rev. B **39**, 4828 (1989) P. Grunberg, U.S. patent # 4,949,039

figure of merit 
$$GMR = \frac{\Delta R}{R} \equiv \frac{R_{AP} - R_P}{R_P}$$

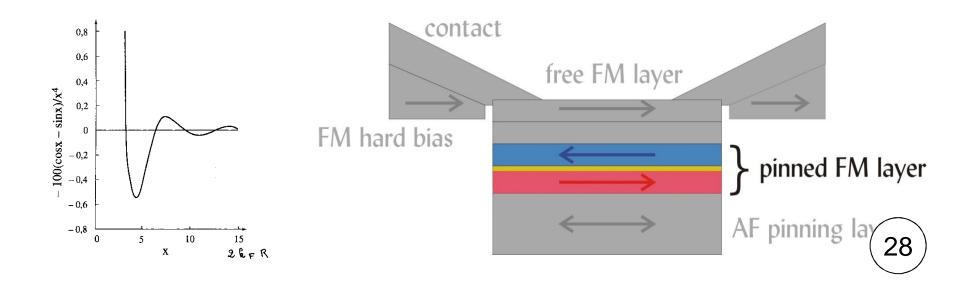
#### Functional layers of a GMR sensor I. the free layer

- Magnetization of the free layer rotates in the stray field of the bit transition
- Requires stable zero-field position parallel to the disk surface
- can be achieved by
  - internal (magneto-crystalline) anisotropy
  - shape anisotropy
  - bias field from hard magnet



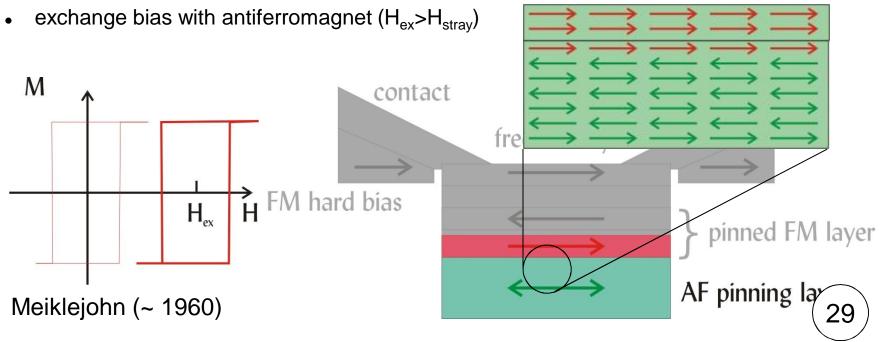
### Functional layers of a GMR sensor II. the pinned layer

- pinned layer provides reference direction for free layer
- stray field should not disturb free layer
  - use 2 antiferromagnetically coupled magnetic layers
  - oscillating RKKY interaction also found in thin 3d-metal films separated by suitable non-magnetic spacer layer, e.g.,Fe/Cr/Fe, Co/Cu/Co, CoFe/Ru/CoFe,õ
- requires stable position perpendicular to the disk surface
  - in-stack bias with hard magnetic layer
  - exchange bias with antiferromagnet



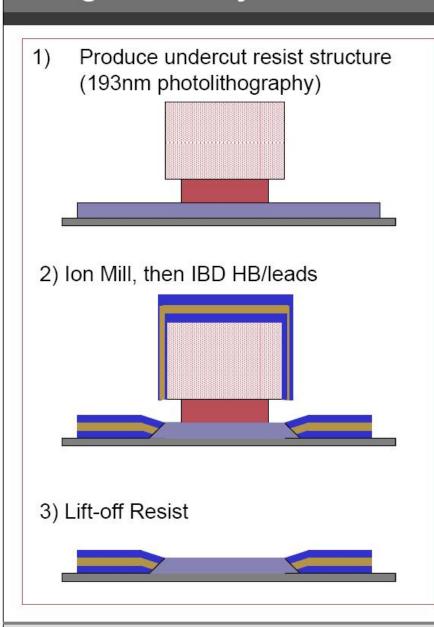
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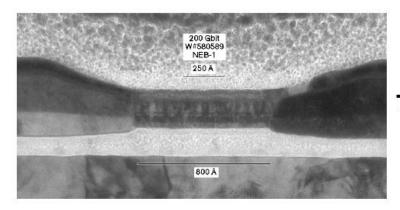


#### Higher density → decrease sensor trackwidth

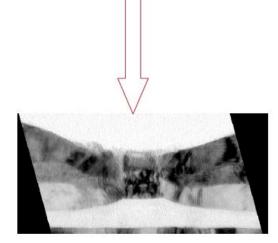




#### Excellent process control is possible

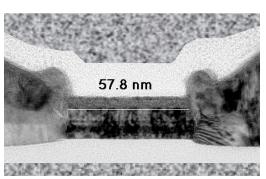


TW=80nm

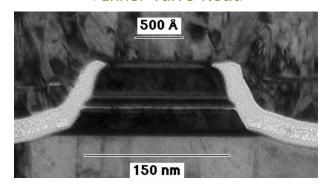


TW=13 nm

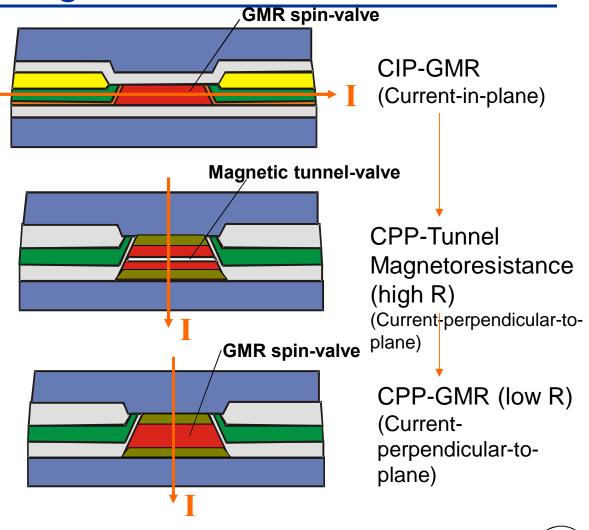
# New sensor geometries required for continued scaling



Tunnel-valve head

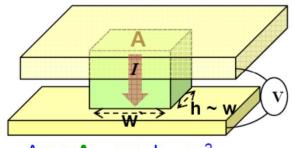


driven by Éscaling of gap ÉΔR/R improvement Éabsolute value of R



#### Read sensor for high-density magnetic recording



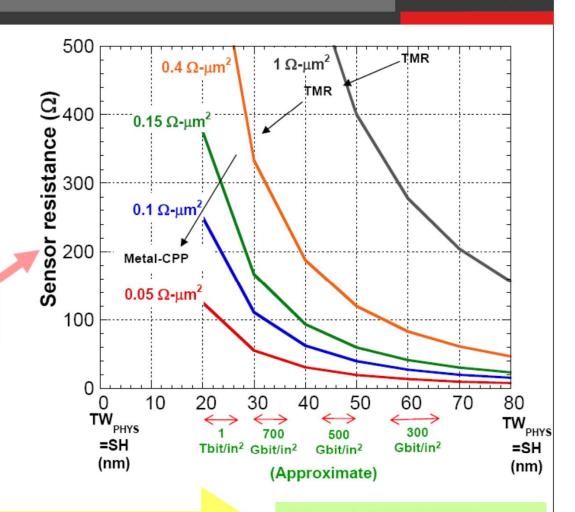


Area  $\mathbf{A} = \mathbf{w} \times \mathbf{h} \sim \mathbf{w}^2$ 

 $R_{Sensor} = R_j (\Omega - \mu m^2) / A$ 



R<sub>Sensor</sub> <u>increases</u> with decreasing sensor size (higher recording density)



#### R << $\sim$ 500 $\Omega$ is desirable

#### Low R =

- Low noise
- Large bandwidth (high data rate)

For density >> 300 Gb/in<sup>2</sup> Need sensor RA << 1  $\Omega$ - $\mu$ m<sup>2</sup>

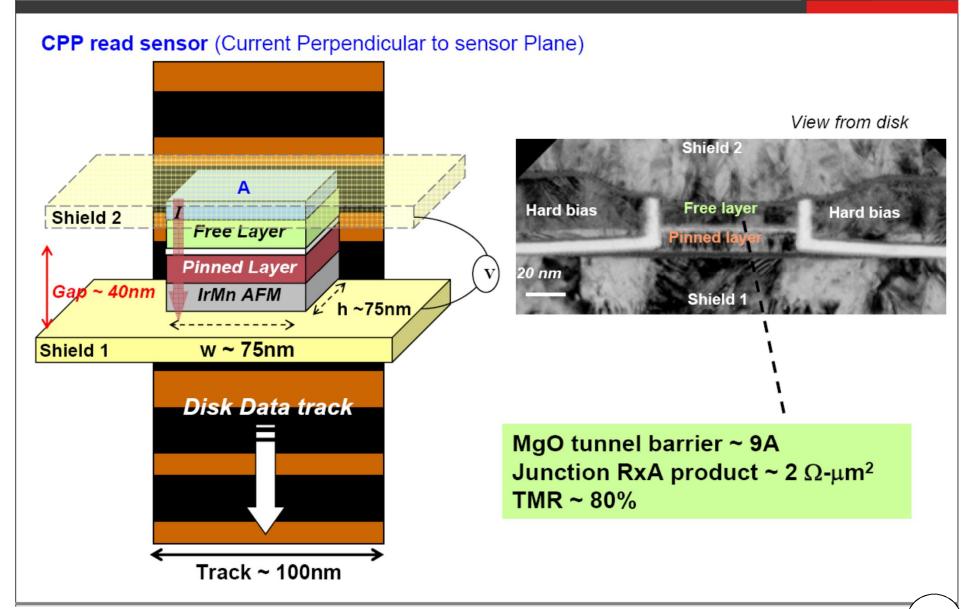
#### **All-metal CPP-GMR**

 $0.02 - 0.1 \Omega - \mu m^2$ 

Low-resistance, robust sensor down to smallest dimensions

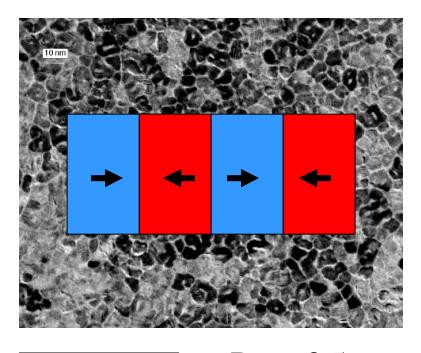
#### Today's CPP-TMR sensor (~250 Gb/in<sup>2</sup>)



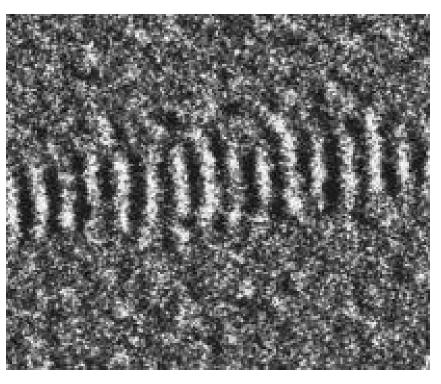


## Media

### Bits & Media Microstructure



<D> = 8.5 nm100 nm +/- 2.5 nm



1000 nm

SNR  $\propto \sqrt{N}$  N: # of grains/bit

## Signal and Noise

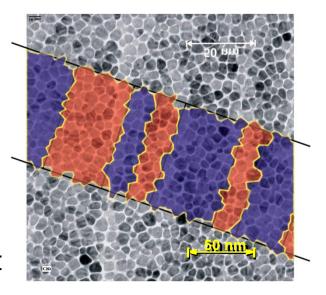
#### Signal

- Volume and moment of magnetic material
- Orientation of grains (relative to reader and track)
- Complete grain switching

#### Noise

- Uncertainty in transition position
- Width of transition
- Granularity of medium
- Magnetic reader (GMR) noise
- Electronic amplifier noise (Johnson, shot etc.)

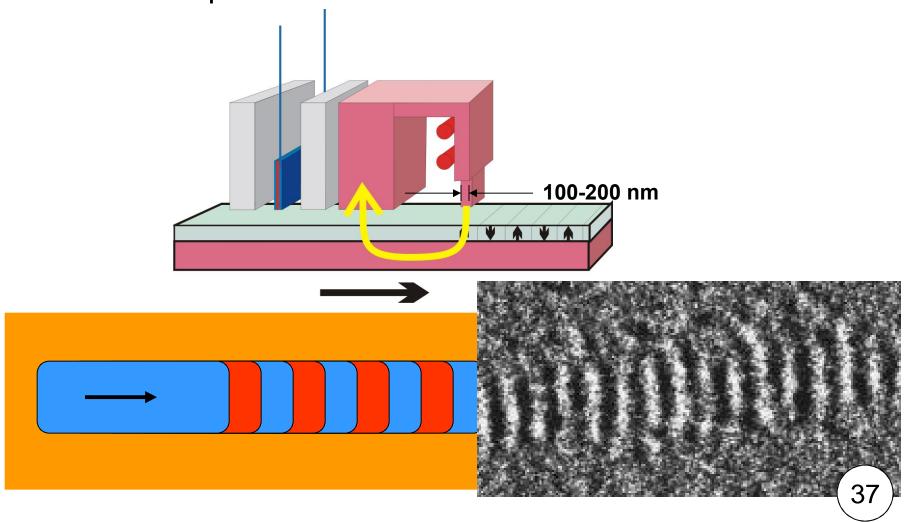
$$SNR_{media} \propto \sqrt{N}$$
 N: # of grains/bit



Perpendicular granular media

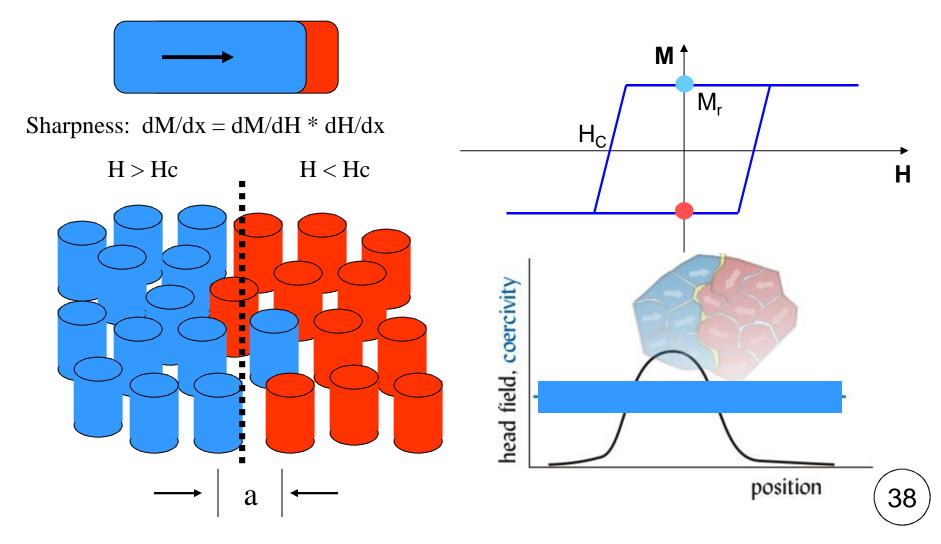
### Magnetic super-resolution

Head pole is > 100 nm but bits are 15 nm?



### Density limit I

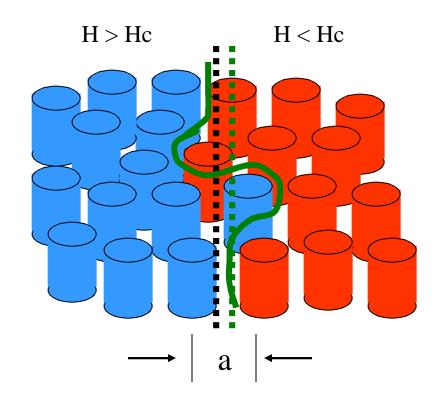
How sharp can you make the transition?



### Density limit II

How accurately can you place the transition?



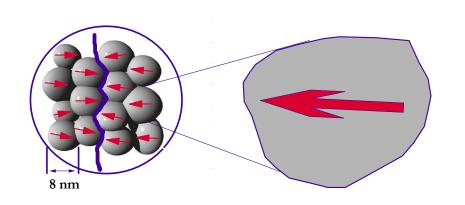


$$\sigma_{x} = \frac{\pi^{2} a}{4} \sqrt{\frac{s}{3W}}$$

 $\sigma_{\rm x}$  < 10% of bit length

 $5\sigma_x$  half the bit length  $10^{-6}$  probability

### Magnetic vs. thermal energy



#### $Magnetic\ energy\ E=K_UV$

$$K_UV = 100 k_BT$$
  $\tau > age of the universe$ 

$$K_U V = 45 k_B T$$
  $\tau \sim 10 \text{ years}$ 

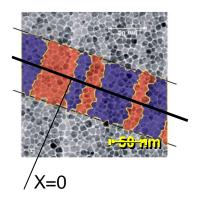
$$K_U V = 25 k_B T$$
  $\tau \sim 7 seconds$ 

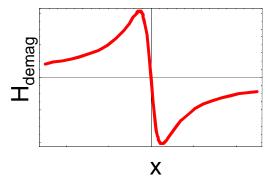
In products often  $K_UV/k_BT > 70$  is used due to other contributions, operation temperature range *etc*.

In longitudinal media the demag fields at a transition help drive thermal activation

$$E_B^+ = \Delta E = K_U V (1 - h)^2$$

$$h = \frac{H_{app} + H_{demag}}{H_k}$$





demag. field profile from the center of an isolated transition

#### Reversal of a single domain particle

Simple coherent noninteracting rate equation model

$$\tau_{\pm}^{-1}(h) = f_0 \exp\left(-\frac{E_B^{\pm}(h)}{k_B T}\right)$$

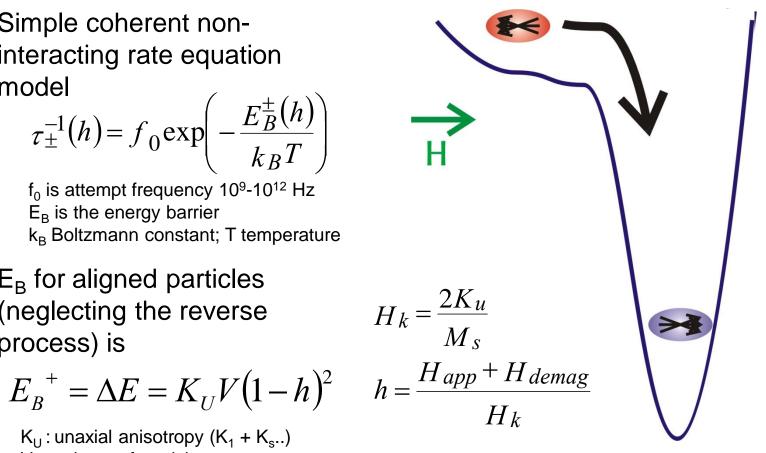
f<sub>0</sub> is attempt frequency 10<sup>9</sup>-10<sup>12</sup> Hz E<sub>B</sub> is the energy barrier k<sub>B</sub> Boltzmann constant; T temperature

E<sub>B</sub> for aligned particles (neglecting the reverse process) is

$$E_B^{+} = \Delta E = K_U V (1 - h)^2$$

 $K_{11}$ : unaxial anisotropy ( $K_1 + K_{s...}$ )

V: volume of particle



E.C. Stoner and E.P. Wohlfarth *Phil. Trans. Roy. Soc.* **A240** (1948) 599 R. Street and J.C. Woolley Proc. Roy. Soc. A62 (1949) 562 L. Neel Compt. Rend. Acad. Sci., Paris 228 (1949) 664 W.F. Brown Phys. Rev. 130 (1963) 1677

### Signal decay

Thermally activated magnetization reversal has two important consequences for an ensemble of SW-particles ....

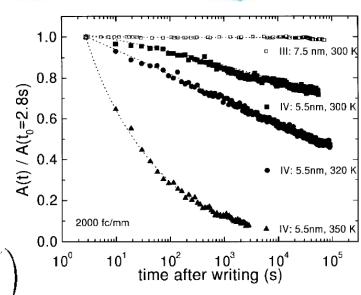
1. magnetization decay

$$E_B(H) = \ln \left(\frac{t_x \cdot f_0}{|\ln x|}\right) \cdot k_B T$$
$$t_x = |\ln x|(f_0)^{-1} \exp\left(\frac{E_B(H)}{k_B T}\right)$$

x: fraction of retained magnetization after time t<sub>x</sub>

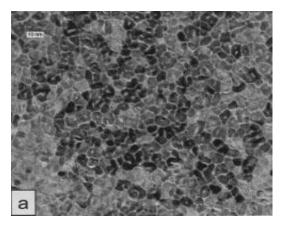
2. time dependent coercivity

$$H_{CR}(V, t_p) = H_0 \cdot \left(1 - \left[\frac{k_B T}{K_u V} \cdot \ln\left(\frac{t_p \cdot f_0}{\ln 2}\right)\right]^n\right)$$



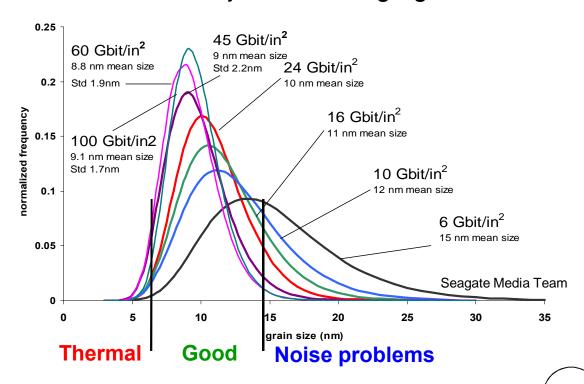
#### Grain size and distribution reduction

CoCrPtB - 35 Gbit/in<sup>2</sup> medium



- Amorphous grain boundaries
  - b Torm

- Smaller grains, better isolation
- Butõ
  - Thermal activation of small grains
  - Increased jitter from large grains



#### The importance of grain size distributions

assume log normal distribution of particle sizes

#### The importance of grain size & distribution

criterion for data stability: allow max. 10% signal loss over 10 years

logarithmic time scale is deceptive

1 sec

 $1 \text{ day} \sim 10^5 \text{ sec}$ 

1 year ~ 3·10<sup>6</sup> sec

10 years ~  $3.10^7$  sec

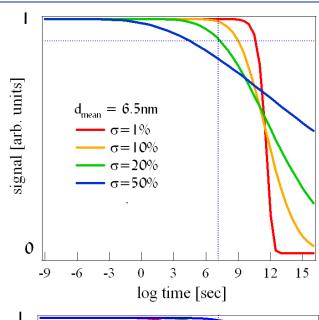
 $300.000 \text{ years} \sim 10^{12} \text{ sec}$ 

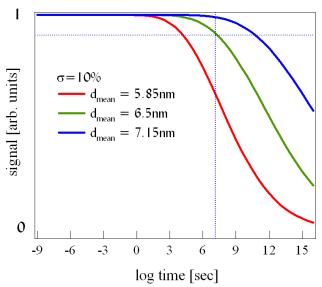
media parameter

 $M_S = 350 \text{ emu/cm}^3$ 

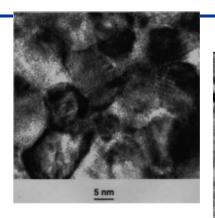
 $K_{IJ} = 2.5 \cdot 10^6 \text{erg/cm}^3$ 

t = 20nm





#### Distribution Narrowing



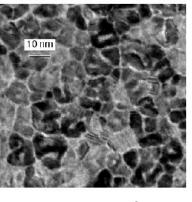
10 Gbit/in<sup>2</sup> product media

12 nm grains

 $\sigma_{area} \cong 0.9$ 

J. Li, *et al.*,

J. Appl. Phys. 85, 4286 (1999)



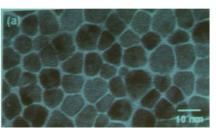
35 Gb/in<sup>2</sup> prototype media

8.5 nm grains

 $\sigma_{area} \cong 0.6$ 

M. Doerner et al.,

IEEE Trans. Mag. 37 (2001) 1052



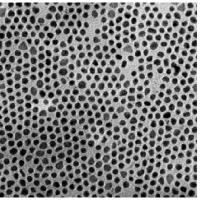
600 Gb/in<sup>2</sup> prototype media

8.5 nm grains

 $\sigma_{area}\cong 0.2$ 

Tanahashi et al.

**TMRC 2008** 



Nanoparticle arrays

4 nm particles

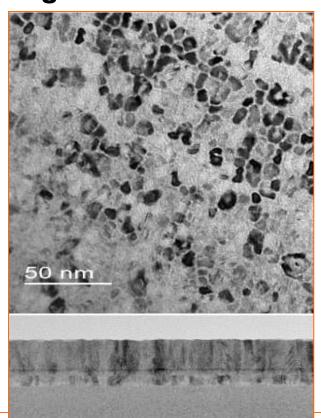
 $\sigma_{\text{area}} \cong 0.05$ S. Sun *et al.*,

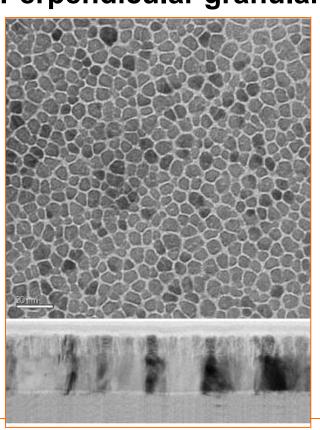
Science 287,1989 (2000) 1989

simultaneous nucleation and growth in PVD leads to log-normal distribution – fundamental problem! challenge: novel, mass production compatible deposition techniques

### Microstructural Comparison

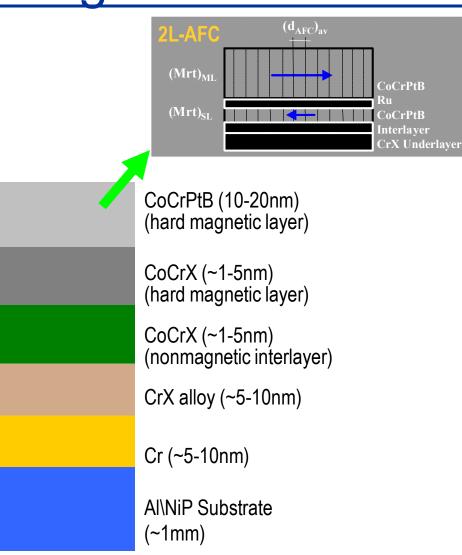
#### Longitudinal conventional Perpendicular granular

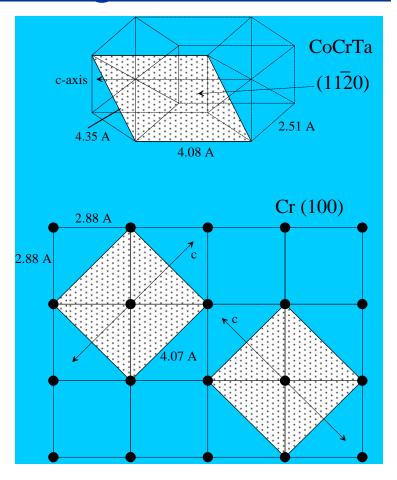




 Granular segregation for perpendicular media enables significantly sharper grain definition.

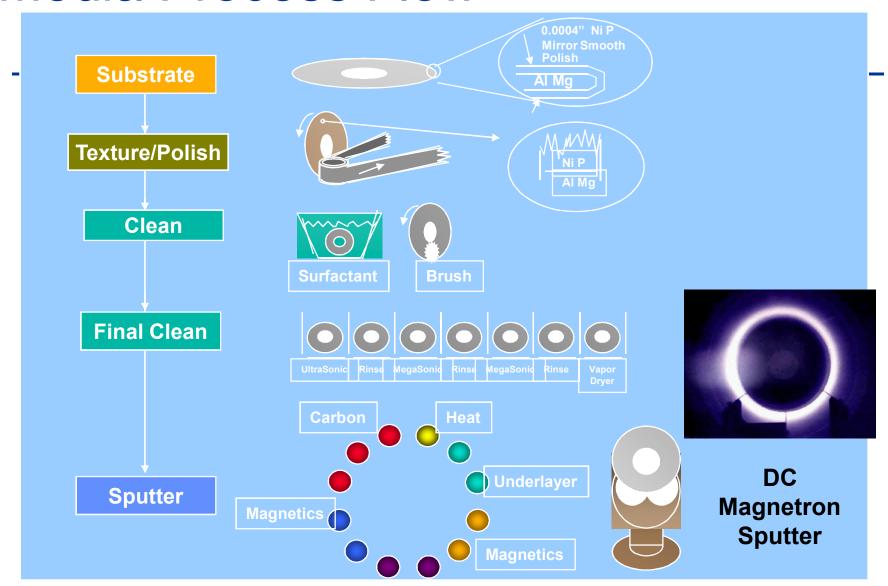
### Longitudinal Media Design





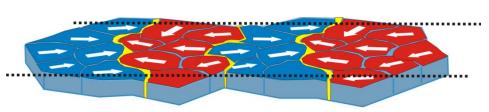
<11.0> hcp alloys epitaxially grown on <200> Cr\CrX template

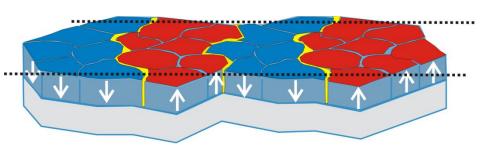
#### Media Process Flow



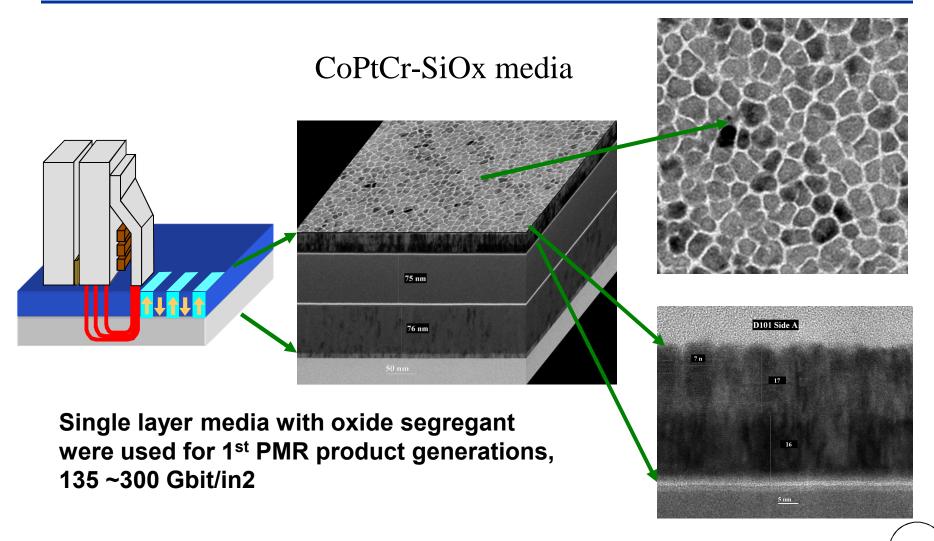
#### Media differences LMR ↔ PMR

- position in write gap in combination with soft magnetic underlayer (SUL) provides higher write field, allows higher K<sub>U</sub>, H<sub>SW</sub> media
- magnetostatics of high density recording destabilizes longitudinal bits but stabilizes perpendicular bits
- perpendicular media have near perfect magnetic orientation
- tunability of exchange coupling and magnetostatics (composite media)
- SUL requirements
  - high M<sub>S</sub> to match write head material
  - high permeability >50





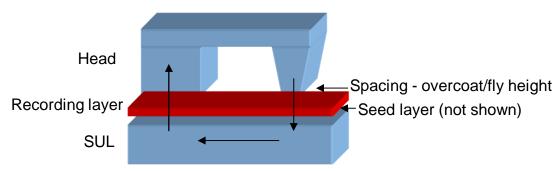
### Perpendicular media

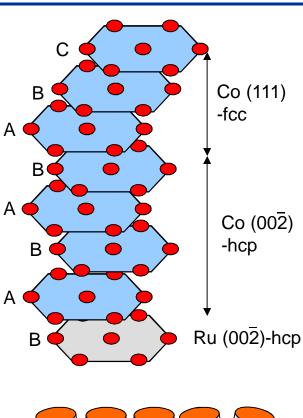


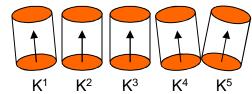
#### CoCrPt-oxide perpendicular media

#### Challenges

- grow grains with hcp c-axis perpendicular to the plane without stacking faults and with small dispersion of easy axes angles
- minimize spacing loss between SUL and recording layer
- significant constraint on seed and underlayer structure

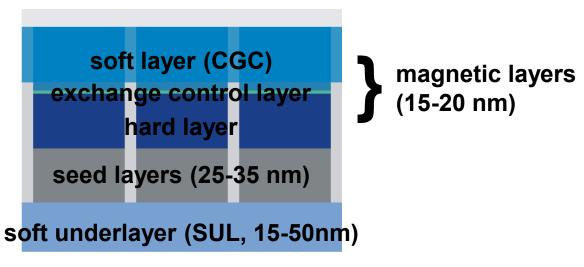


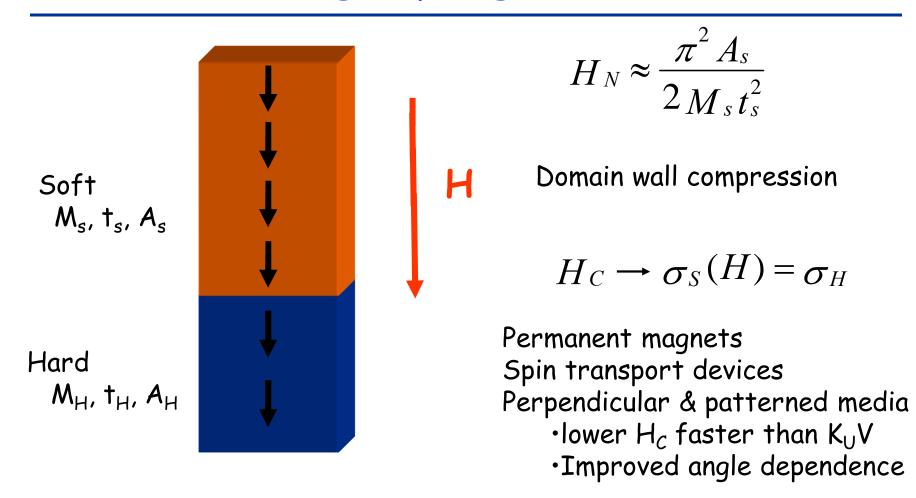




#### Novel media ideas. CGC & ECC

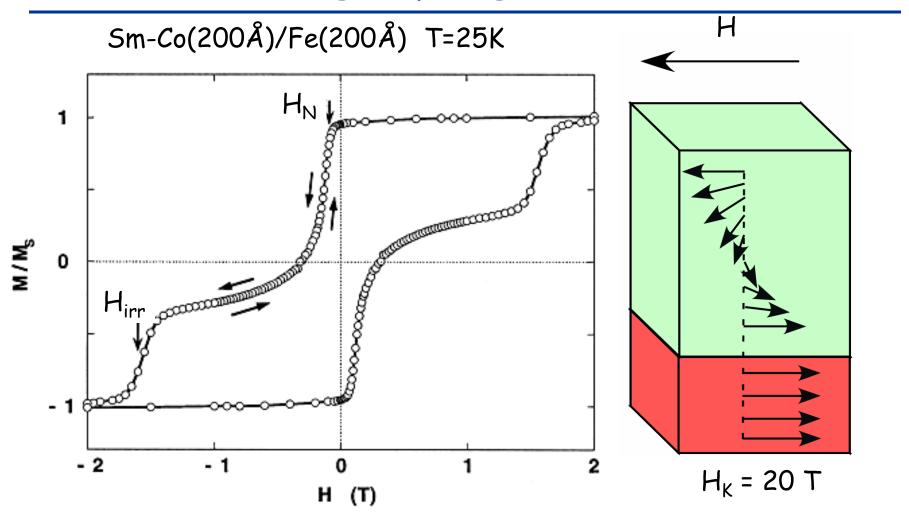
- a laterally more exchange coupled layer, typically near the top of the layer structure, allows controlled and uniform grain-to-grain exchange, reducing the switching field distribution. this type of media is called Continuous Granular Composite (CGC) media
- splitting each grain into a hard and soft region with controlled exchange coupling between the regions allows to reduce the required switching field without reducing the energy barrier. this type of media is called Exchange-Coupled-Composite (ECC) media (first published by R.H. Victora, IEEE Trans. Magn. 41 (2005) 537)
- Applying a field rotates the soft region and so changes the angle of the total effective field acting on the hard region  $(H_{app} + H_{ex})$



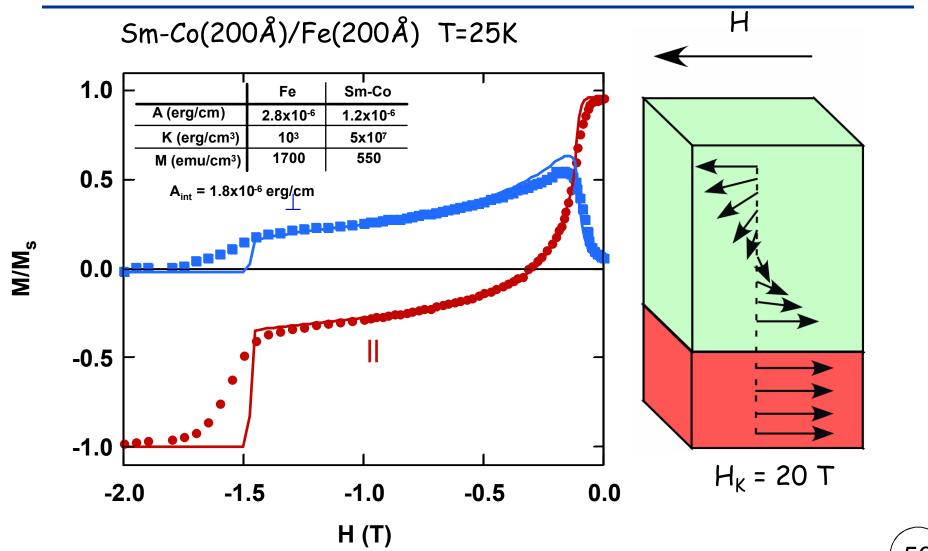


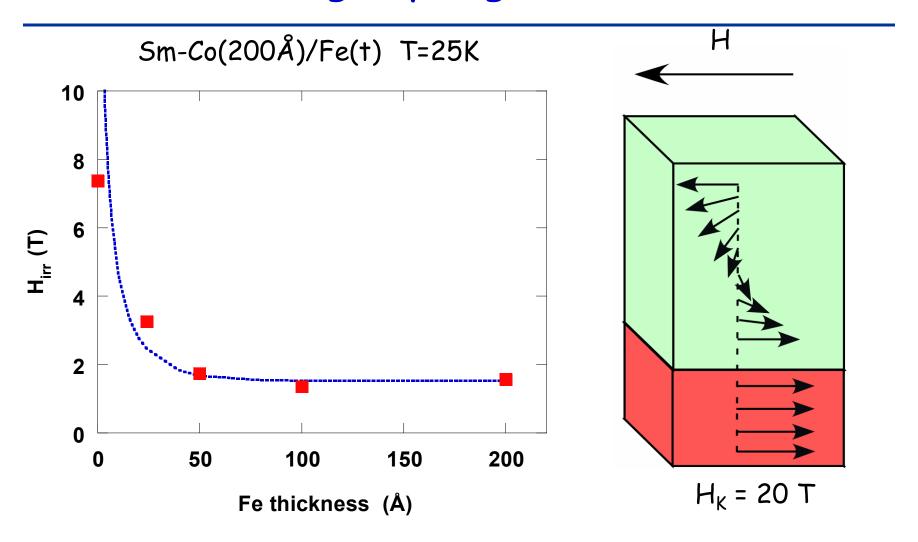
Goto *et al.*J. Appl. Phys. **36**, 2951 (1965).

E. Fullerton, J. Magn. Magn. Mat. 200, 392 (1999)



E. Fullerton et al., PRB 58, 12193 (1998).





#### Exchange spring advantages

## $H_{\mathcal{C}}$ decreases much faster than the energy barrier

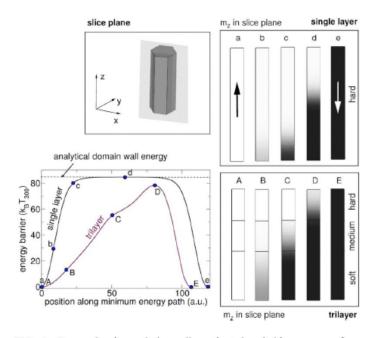


FIG. 3. Energy barrier and thermally activated switching process for a single phase media and the trilayer of Fig. 1. The hardest layer of the trilayer is 7 nm. The grain diameter is 5 nm. The z component of the magnetization during thermally activated switching is color coded.

D. Suess, Appl Phys Lett 89 (2006) 113105

 $H_{\mathcal{C}}$  depends on the domain wall energy of the hard layer

$$H_C \propto \sqrt{KA}$$

$$\sigma H_K \to \sigma \sqrt{H_K}$$

Soft layer provides a torque so reduced angular dependence of  $H_{\mathcal{C}}$ 

Unusual and potentially useful dynamics

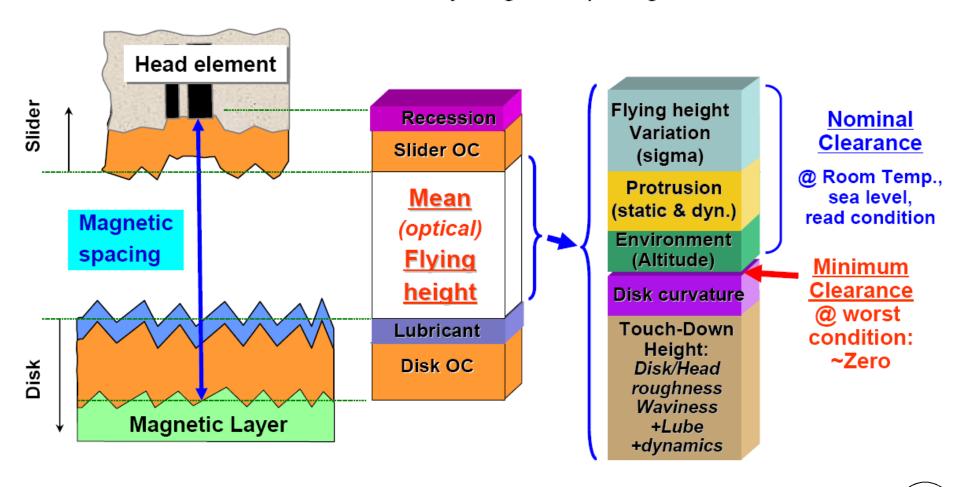
#### Basic Perpendicular Media Structure

Film **Function** " Protecting the film Over coat "Bonding with lube "Intergranular exchange coupling **Top Magnetic** "Biggest impact on reading signal Layer (CGC) "Impact on writing and erasing **Middle Magnetic** "Providing knob for adjusting (Mrt, exchange, Hc, Hn, etc.) and thermal stability Layer (M2) **ECC** Vertical exchange adjusting "Adjusting vertical exchange. ECC-ness, **Bottom Magnetic** adjusting Hc, Hn Layer (M1) "Thermal stability "Foundation for the magnetic layers, critical to media noise Interlayer "Foundation for the magnetic layers. Critical in establishing orientation and grain size and distribution. "Major knob for grain size and grain size distribution Single or AFC SUL "Flux conducting (in writing) "Recording bit (in reading)

### Head-Disk-Interface (HDI)

#### **HDI at Ultra Low Flying Height**

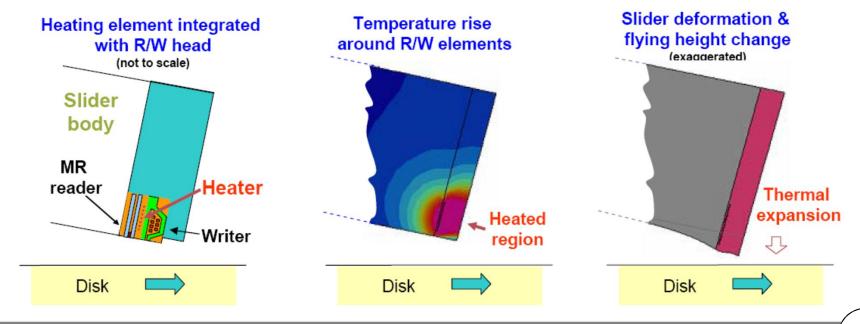
- For 70 Gbits/in2 Areal Density magnetic spacing ~ 18 nm
- For 1 Tbits/in2 Areal Density magnetic spacing < 7 nm



#### Flying-Height Control: Thermal Actuator



- TFC (Thermal Flying-height Control) recent introduction ~2005
  - Magnetic Spacing is one of strongest levers for areal density
  - → Control flying height with small thermal actuator (heater) built into head
  - Only active during read or write → better reliability
  - Compensates head protrusion (deformation) due to writing, temperature change, etc.
  - Absorbs fly-height differences between heads, brings <u>each</u> head to lowest possible safe flying height.
  - requires 6-pad slider and 6-leads connecting to redesigned preamp/write-driver chip

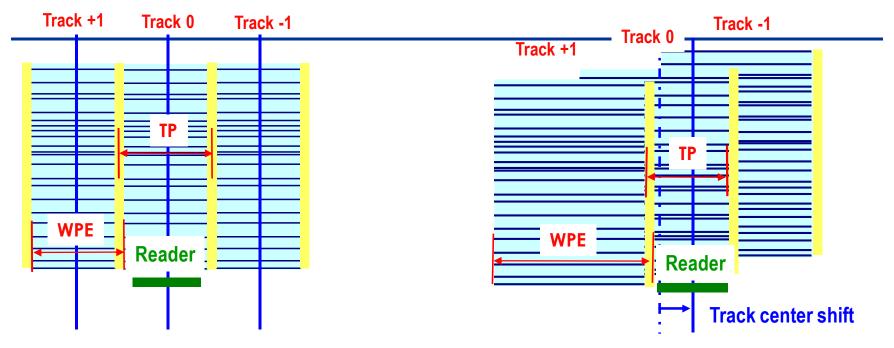


#### Limits of ‰onventional+magnetic recording

### Extending PMR

- Need PMR extension to 1.5 Tbpsi or higher
  - Higher linear density no clear path (SFD reduction, grain size reduction)
  - Higher track density doable
- Steps to improve track density
  - Reduction of both writer and reader dimension conventional PMR
    - Head writability limitation controlled by  $4\pi Ms$  of writer material
    - Thermal stability limitation of media Hc
  - Reduction of only reader dimension S(hingle)MR
    - Use wide head to write higher track density
    - Reader dimension limitation controlled by line-width capability in semiconductor
  - 2D SMR
    - No need to reduce both the reader and writer dimension
    - Implementing ISI (inter symbol interference) in step 1
    - Full 2D decoding of read back signal in step 2
- Future Techniques to cover 1.5 Tbpsi
  - HAMR, BPM, HAMR + BPM, ....

#### How SMR works



#### **Conventional:**

side

Random access of each data track
Nearly no overlapping between tracks
Track pitch is controlled by writer (WPE) and
reader dimensions
Adjacent track erase could comes from both

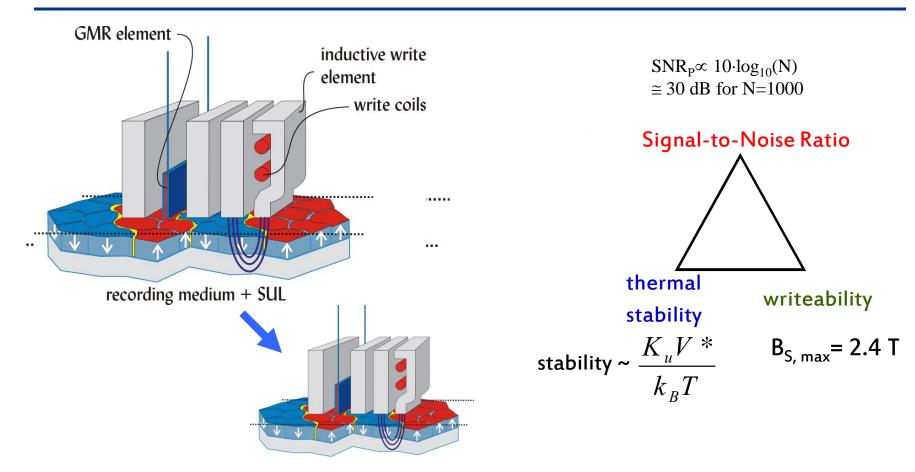
#### **Bandit (Shingle):**

Data track written in sequential order
Could have severe overlap between tracks
Track pitch is controlled primarily by reader
dimension
Adjacent track erase only comes from one side

### Advantage & drawbacks of SMR

- Head and media writability requirement is less critical
- For the same head/media
  - Typically see 10-15% gain in SMR at MD and with reasonable reader and writer margin
  - The SMR gain is higher at ID or OD
    - SMR track pitch is nearly flat from ID->MD->OD
    - Conventional PMR track density is lower at ID and OD
  - The SMR gain is higher if WPE >> reader dimension
- SMR has less requirement for erasure
- Performance hit
  - No more random access for write
  - Erase and write a band of data
- Format efficiency loss

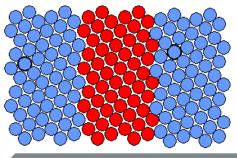
#### Limits to £onventionalqscaling in magnetic recording



The achievable areal density using £onventionalqscaling is limited by trade-off between SNR, thermal stability and writeability

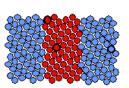
#### **Superparamagnetic Effect**

#### **Superparamagnetic Limit**



To preserve SNR, number of grains in a bit must be constant.

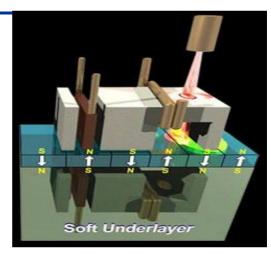
 $\overline{\text{SNR}} \sim \log_{10}(N)$ Therefore higher densities require smaller grains



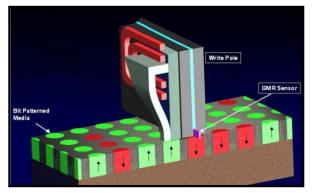
The smaller bits have a higher probability of flipping and the data is unstable

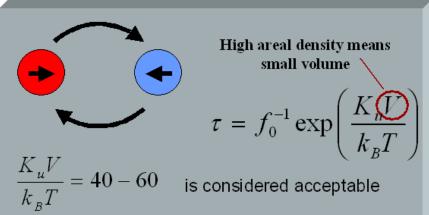


#### **HAMR: Increase K**



#### **BPM: Increase V**





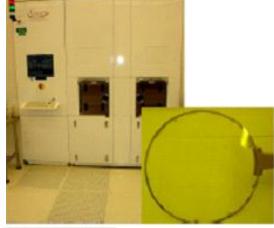
### Patterned Media

#### **Patterned Media Fabrication**

- 1. Mastering
  - ☐ Rotary-stage e-beam lithography (MUST)
- 2. Template fabrication
  - □ Directed self-assembly (DSA) of block copolymers
  - **□** Double patterning (alternative)
  - □ Template replication
- 3. Nanoimprint lithography (NIL)
  - □ UV cure
  - **□** Template cleaning
- 4. Magnetic dot formation
  - ☐ Ion beam etch
  - □ Ion implantation
- 5. Metrology
  - ☐ Critical dimension & sigma control
  - Defect control

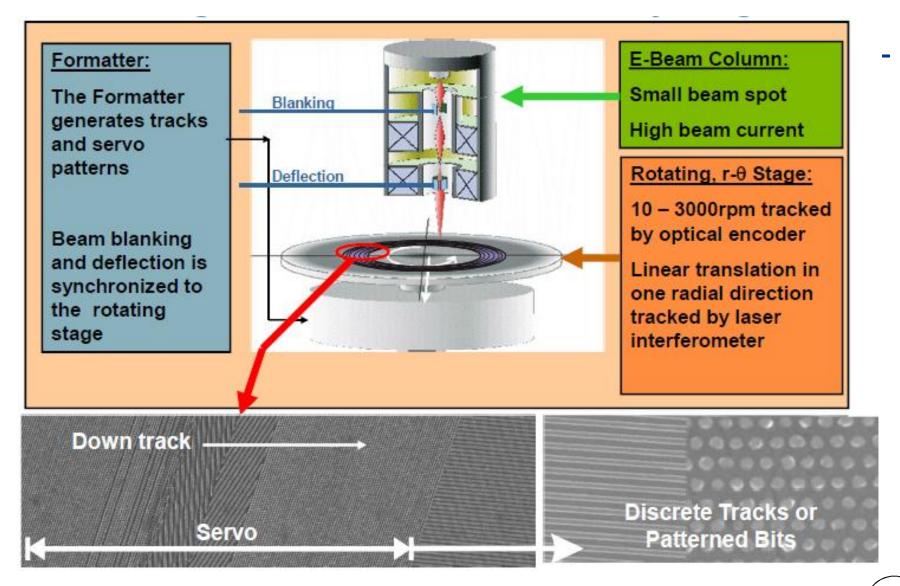




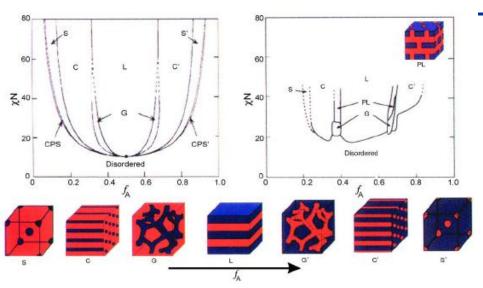




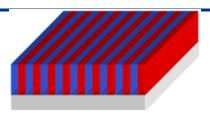
#### Mastering: Rotary-Stage E-Beam Writer



# Block Copolymer Self-Assembly: Pattern Resolution Set by Materials

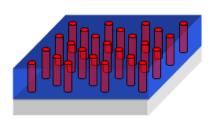


\* F.S. Bates, G.H. Fredrickson, Phys. Today 1999



□1-D (2X lithography →2D) □Orientation control □Flexible for skew □Low-χ block copolymers (doublepatterning)

Lamella

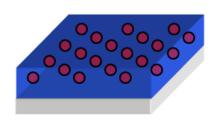


Cylinder
□2-D
□Orientation control
□Inflexible for skew
(HCP)
□High-χ block
copolymers



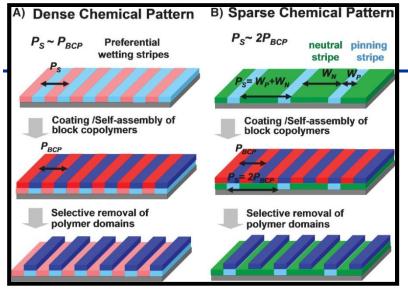
$$L_0 \propto N_{min}^{1/2}$$

$$\chi N_{min} = 10.5$$



Sphere
□2-D
□Inflexible for skew
(HCP)
□High-χ block
copolymers

#### **DSA for Density Multiplication**





□Lamella system: J. Y. Cheng et al., Adv.

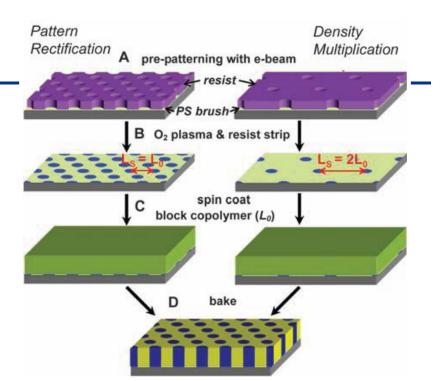
Mater. 2008 (IBM)

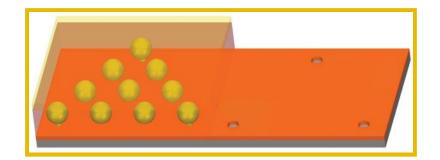
□Cylinder system: R. Ruiz/P. Nealey *et al.*, Science 2008 (HGST & University of

Wisconsin)

□Sphere system: S. Xiao et al., Adv. Mater. 2009 (Seagate Technology &

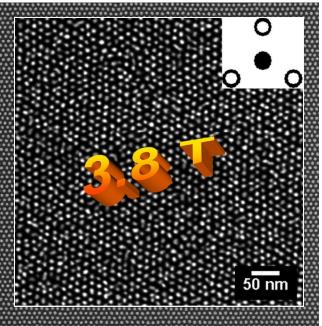
**University of Massachusetts)** 

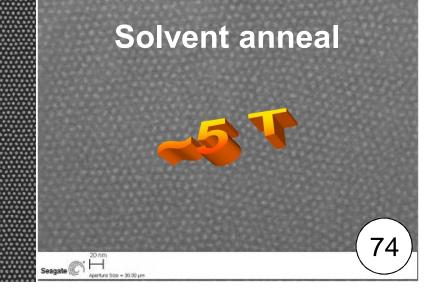


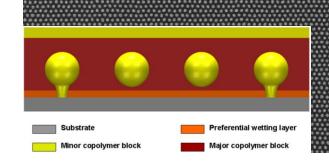


#### Spherical PS-b-PDMS: Up to ~5 Tdpsi (6nm hp)

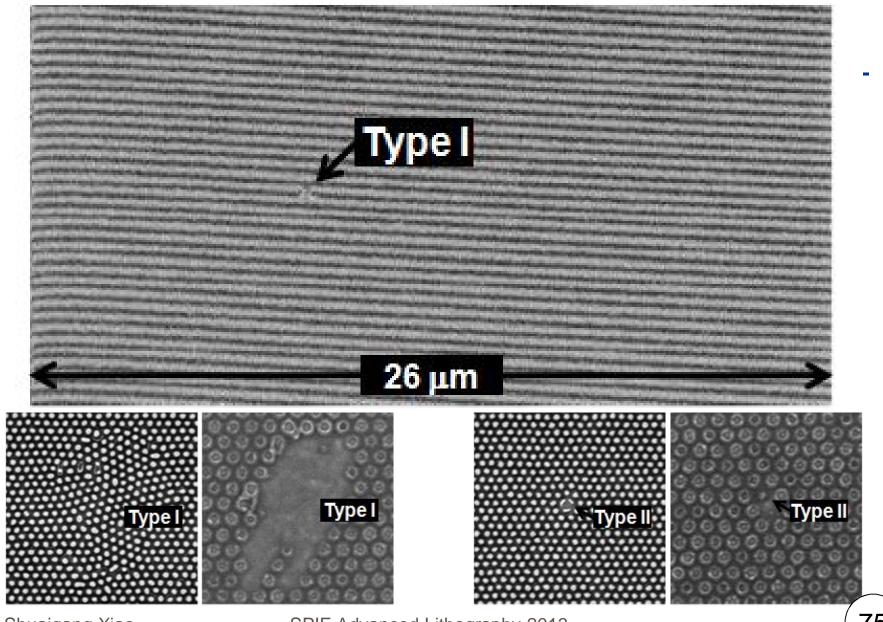
- □4X-16X AD multiplication using spherical PS-b-PDMS
- (S. Xiao et al. Adv. Mater. 2009)
- ☐Advantages over PS-b-PMMA
  - □Better AD extendibility (~5 T vs. ~ 1 T)
  - ☐General approach to various BCPs due to the elimination of the need of orientation control



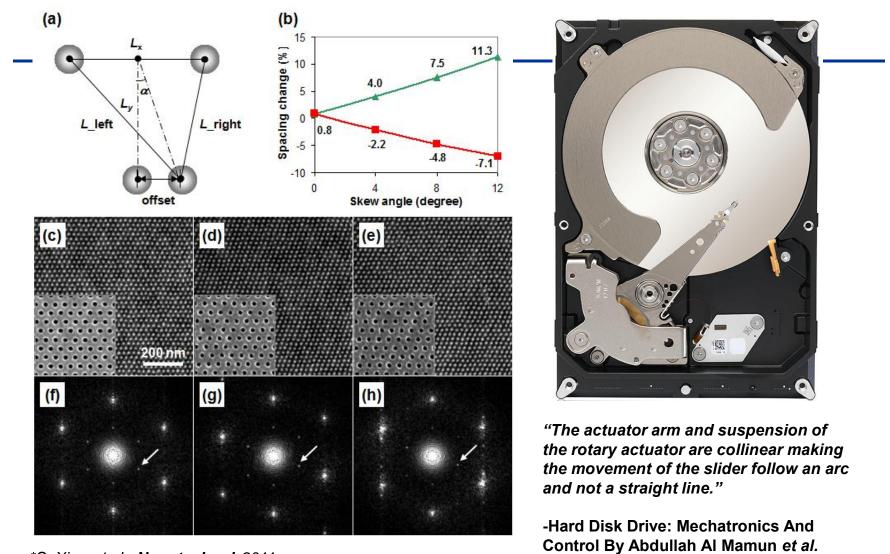




# **Challenge: Defect Control**

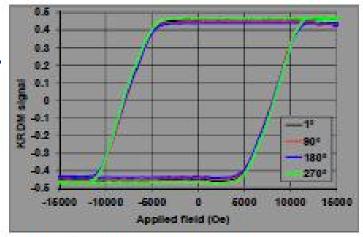


## **Challenge: Skew (Deviation from HCP)**

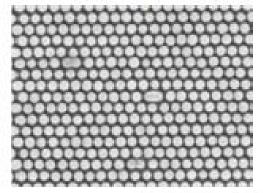


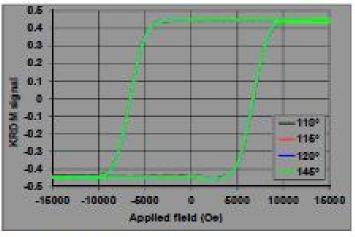
\*S. Xiao et al., Nanotechnol. 2011

#### **Ion Implantation**

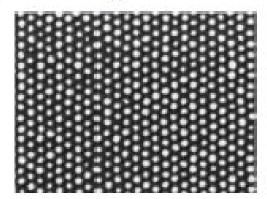


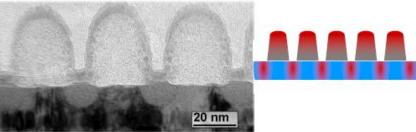
Ion implanted media @ 500G





Ion implanted media @ 1T

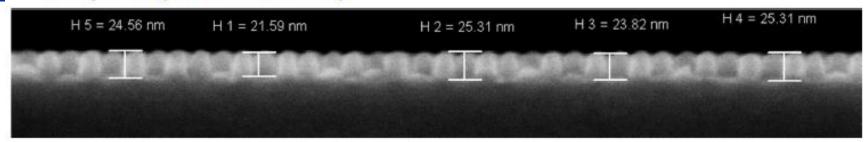




SPIE Advanced Lithography 2013

### 1.5 Tdpsi Media (11 nm hp)

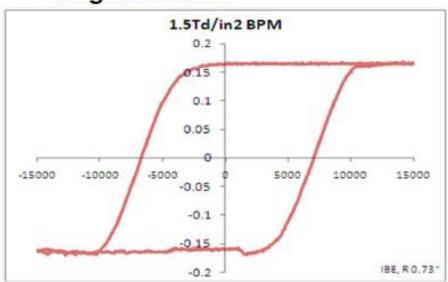
#### Template (cross-section)



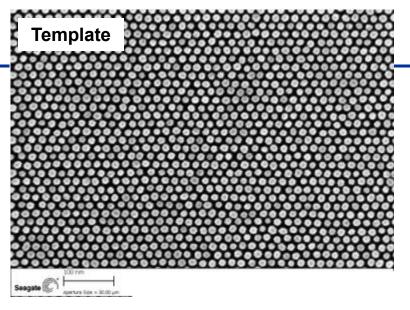
#### **Fabricated Media**

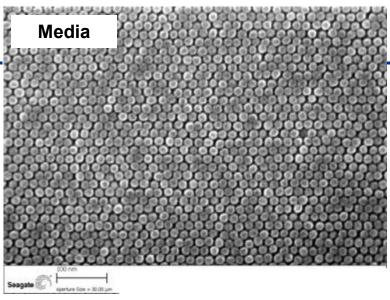
# RAITH/1501\* Major RODERCE Eff + 2-30 kV Expect A + 16-em Class 36 Apr 2612 foot Valuable = 12 and 30 halls SAME ALL SECTION IN-TERMS 40.00 to Apr 2610 to 30 km / 2 and 2610 to 30 km / 2

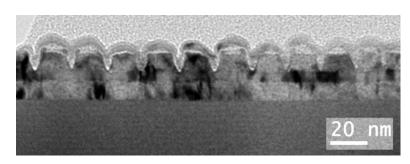
#### Magnetic data

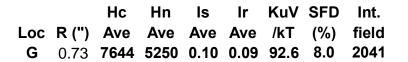


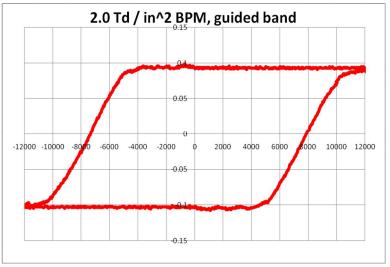
### 2 Tdpsi Media (9.6 nm hp)











#### **Summary**

- BPM fabrication involves multiple lithography techniques, i.e. e-beam, nanoimprint, DSA, double patterning etc.
- Major challenge in BPM lithography is master template creation, which requires combination of rotary-stage e-beam/DSA/double patterning.
- DSA using block copolymers for BPM application (highest resolution) needs new block copolymer materials, having both high resolution (i.e. extendible to 5-10 Tdpsi or 8-12 nm full pitch) and good pattern transfer capability (i.e. Si-containing).
- HCP systems (i.e. sphere PS-b-PDMS) may support BPM technology demo at 2-5 Tdpsi, with innovative skew solutions, while rectangle systems are more appealing in terms of skew.
- As for magnetic island formation, IBE produced good 1T/1.5T/2T BPM media, and ion implantation is also promising.

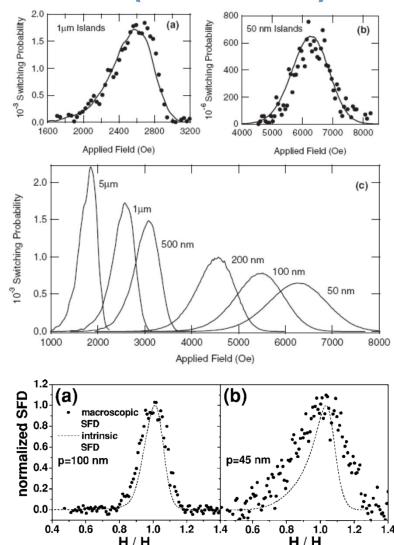
### **Switching Field Distributions (Literature)**

SFD distribution in bit patterned media is size dependent and has various sources<sup>1</sup>

"process damage
"magnetic properties
"dipolar fields

In Co/Pd multilayers on pre-patterned substrates the intrinsic and dipolar contributions to SFD have been quantified by comparing SFDs determined from remanent magnetization curves and the  $\Delta H(M, DM)$ -method<sup>2, 3, 4</sup>

Best published results are  $\sigma_{Kint} = 5-7\%$ 

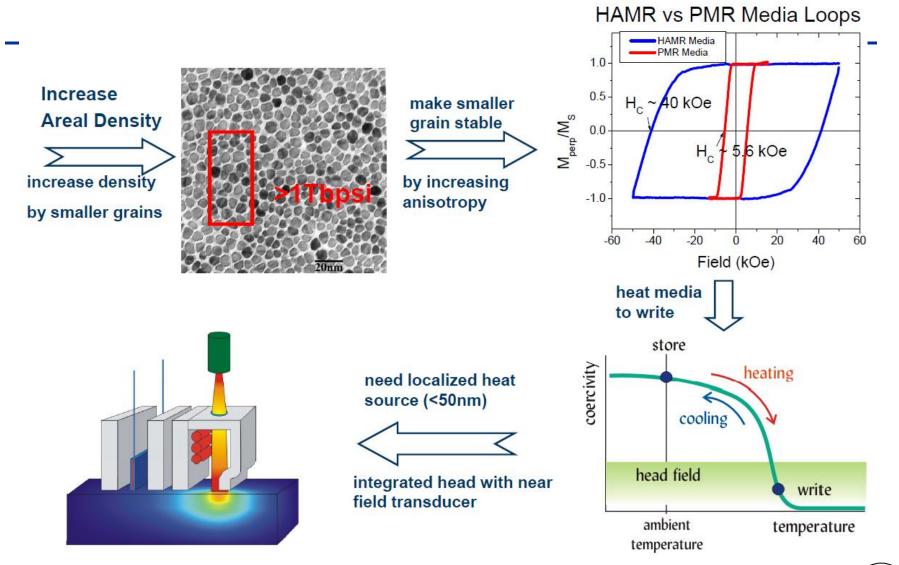




- <sup>1</sup> T. Thomson et al., Phys. Rev. Lett. 96 (2006) 257204
- <sup>2</sup> O. Hellwig et al., Appl. Phys. Lett. 90 (2007) 162516
- <sup>3</sup> A. Berger et al., IEEE Trans Mag 41 (2005) p3178
- <sup>4</sup> D. Weller, A Dobin et al., Intermag 2008

# Heat Assisted Magnetic Recording

## Heat Assisted Magnetic Recording (HAMR)



### Heat Assisted Magnetic Recording

#### Primary Benefits Demonstrated

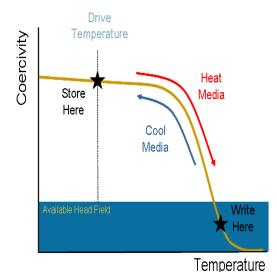
- Ability to fabricate and record on high Hk media (>50kOe)
- Effective write field gradient demonstrated at > 3x perpendicular
- Write width determined by thermal spot not magnetic width

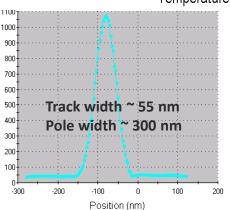
#### Recent Highlights

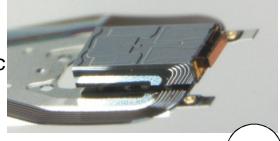
- New FePt media have shown performance benefits with near field transducer heads
- HAMR areal density attainment is greater than 1 Tb/in²
- Integrated HGAs now flowing
- HAMR drives are reading and writing user data

#### Challenges

- Reliability with new thermal stresses in head, HDI and laser
- NFT design for AD, reliability and yield in an integrated head
- HMS and accurate clearance setting with thermal induced dynamic protrusion and media roughness





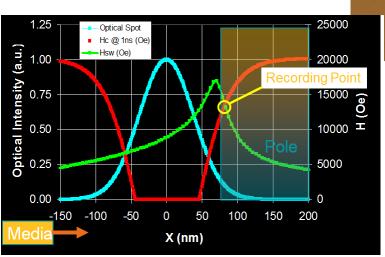


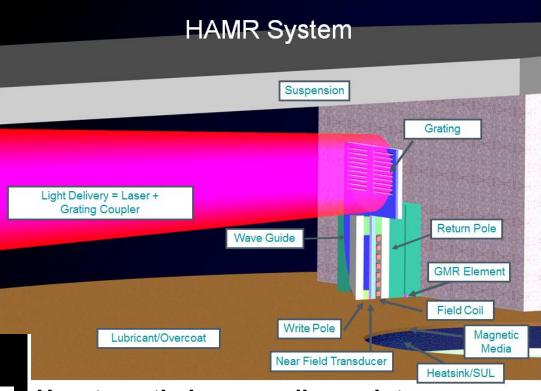
#### An example of HAMR System

"Pole 75 nm from center of optical spot

"Write gradient (thermal and magnetic field) is not optimum

"Recording point is under the pole => Light Blocked?





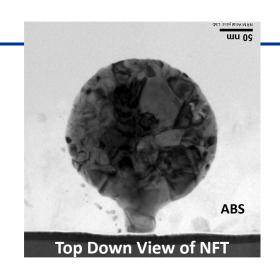
How to optimize recording point:

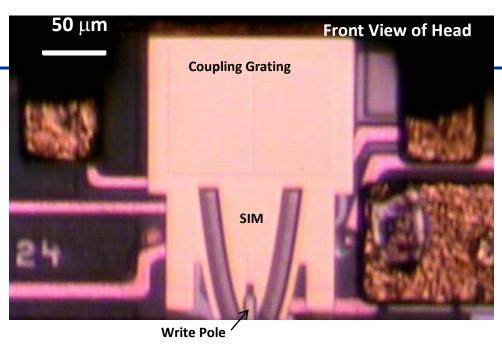
- "Magnetic field (pole position, writer design, write current)
- "Thermal spot (optical spot, power, media thermal properties)
- "Media magnetic properties (Hc, Curie temperature)

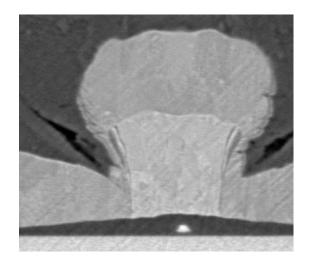
Kaizhong Gao

Intermag 2013

#### Seagate HAMR Integrated (Writer & Reader) Head with NFT

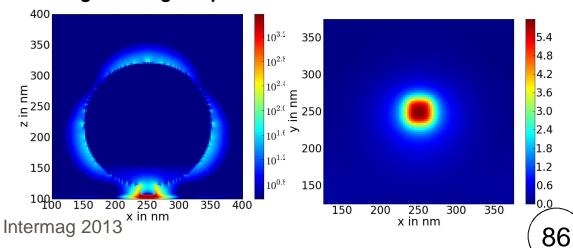






Kaizhong Gao

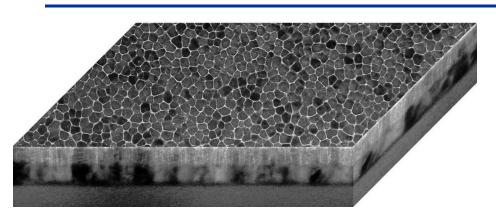
#### Modeling showing the plasmonic resonance and confined E field

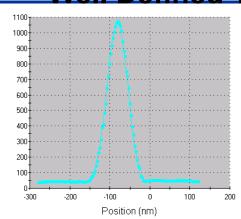


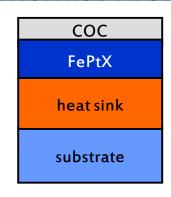
# **HAMR Media Design**

#### **Good Microstructure**

#### **Well Defined Thermal Profile**

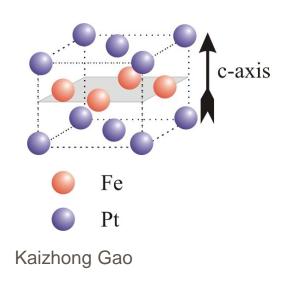






#### **Good Texture and Ordering**

#### **Magnetic Property & Distribution**



FePt L1₀ material used for HAMR media offer

″ higher anisotropy

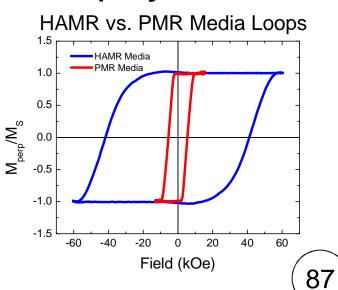
⇒ larger stability

″ larger dH<sub>K</sub>/dT

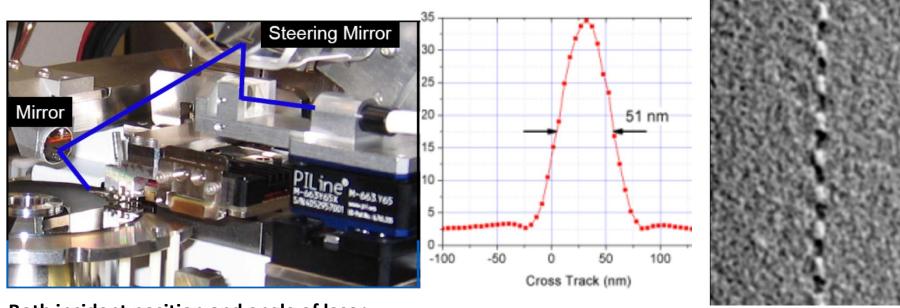
″ lower T<sub>C</sub>

than CoCrPt alloys used in PMR

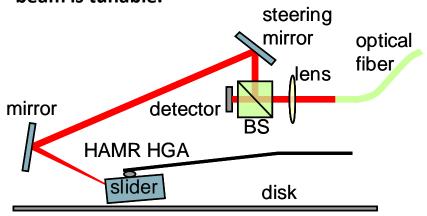
Intermag 2013



# HAMR Spinstand Tester



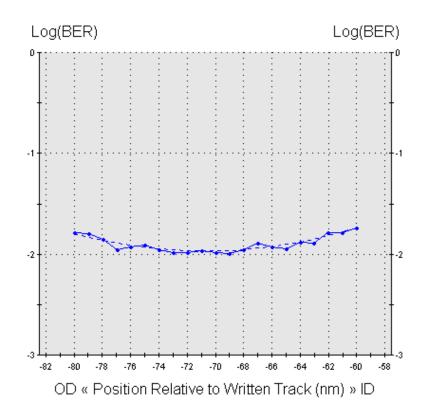
Both incident position and angle of laser beam is tunable.



- **ADC: 242 Gbpsi (15.5 dB ACSNm)**
- " LD: 706 kBPI (BL: 36 nm)
- **TD: 343 kTPI**
- ′ HMS: ~ 15 nm

W. Challener et al, Nature Photonics 3, 220

# Seagate HAMR Demo: 1.007 Tbpsi (1975 kBPI x 510 kTPI)



OTC = 0 nm RWO = -70.72 nm Log(BER) = -1.99 Squeeze = 0 %TP OTC Threshold = -2 Curve Fit = Quadratic

LD = 1975.0 KBPl TD = 510.0 KTPl AD = 1007.3 Gb/ir² Data Rate = 833.9 Mb/s RPM = 4200; Sectors = 16 Radius = 24.384 mm; Skew = 0.00° TD = 510.0 KTPI; TP = 49.8 nm Iw = 61.0 mA bp; Bias = 0.350 mA Code; SID formatted

#### **Key Milestone: High BPI and TPI**

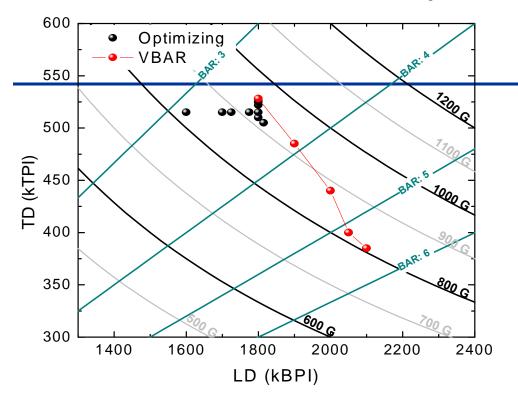
#### **Demo Criteria**

- Adjacent tracks written both sides with same conditions as data track
- On-track BER = 10<sup>-2.0</sup> with no correction/iterations

#### **Procedure:**

- Write data track and then SQZ tracks (1 write/side) at a given TP
- 2. Measure bathtub, record minimum raw BER of bathtub
- 3. Reduce TP until the BER of data track reaches -2.0
- 4. Record AD at this TP and this linear density
- 5. Repeat 1 through 4 for various linear densities and report the highest AD combination and the corresponding linear and track densities.

#### Laser Power Dependence of VBAR

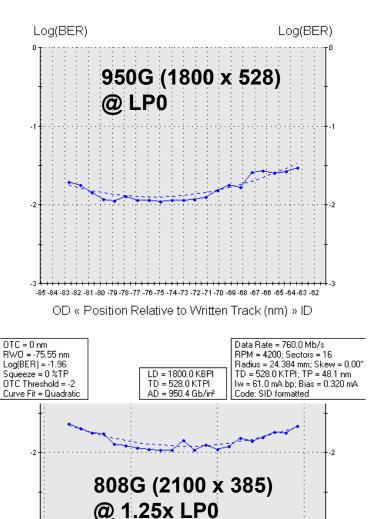




**VBAR:** dominant tuning parameter is Laser Power.

"1st time to achieve 2100 kBPI @ 808Gbpsi in HAMR.

"Results are from another head (NOT from the 1Tbpsi demo head).



OD « Position Relative to Written Track (nm) » ID

OTC = 0 nm RWO = -73.74 nm Log(BER) = -1.97 Squeeze = 0 %TP OTC Threshold = -2 Curve Fit = Quadratic

LD = 2099.9 KBPI TD = 385.0 KTPI AD = 808.5 Gb/ir² Data Rate = 886.7 Mb/s RPM = 4200; Sectors = 16 Radius = 24.384 mm; Skew TD = 385.0 KTPI; TP = 66,1 Iw = 64.0 mA bp; Bias = 0.1 Code: SID formatted

90

# **Areal Density Optimization**

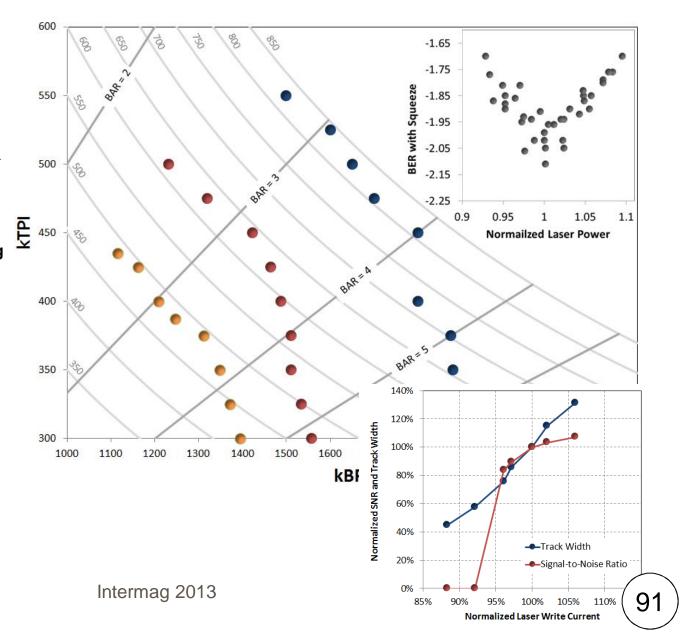
This plot shows three different heads (red, blue and orange) with varying degrees of areal density capability

Each point used the same demo criteria, i.e. On-track BER = -2 with two adjacent tracks with 0% squeeze

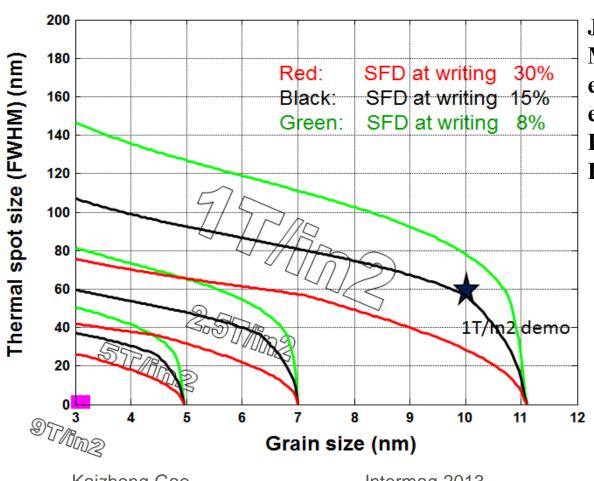
By changing the laser power and re-optimizing the remaining parameters, the same head is capable of multiple areal densities

Once the system has been optimized for a particular laser power, the inset of the plot shows the sensitivity of BER to laser power. If the laser power is reduced the on-track BER drops due to a loss in SNR. If the laser power is increased, the adjacent tracks begin to erase the data

Kaizhong Gao



# HAMR Scaling and Technology Requirement Charts



Jitter over bit length is 16%, Magnetization stability energy over thermal energy is above 80, Recording bit aspect ratio is 5, Read width is 60% of track width.

The smallest grain size 3nm on the figure is determined by the assumption of a maximum achievable anisotropy value

$$K = 0.7 \cdot 10^8 erg/cm$$

Kaizhong Gao

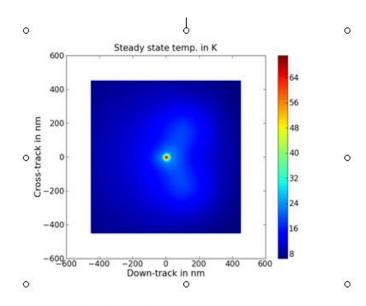
Intermag 2013

# Combined NFT/Thermal/Micro-magnetic Simulation of HAMR 2.9T/in<sup>2</sup> Demo

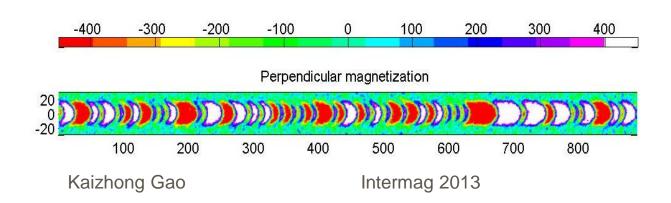
# Combined optical, thermal and micro-magnetic simulation for 2.9T/in<sup>2</sup>

#### Media

T <sub>c</sub>	675 K	σ <sub>Hex</sub> /< H <sub>ex</sub>  >	0.05		
M <sub>s</sub> (300K)	450 emu/cc	Packing fraction	1 (ratio)		
H <sub>k</sub> (300K)	90 kOe	Vol_sigma	0.15 (ratio)		
$g_{H_k}/< H_k >$	0.05	Tc_sigma	0.01		
k_ang	1 degree	<d<sub>g&gt;</d<sub>	4nm		
<h<sub>ex&gt;</h<sub>	10 kOe	Speed	14.4 m/s		
HMSw	7.5nm	t_media	10 nm		
SUL	10	KFCI	variable		



peg width = 10 nm, peg thickness = 10 nm HMS = 7.5 nm FWHM\_DT=36.2nm, FWHM\_CT=35.8nm

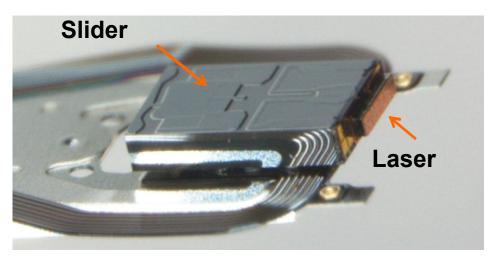


4000 kfci track width 35nm 2.9Tbpsi

# A HAMR Drive

To the right is a photo of an actual HAMR drive. You can tell it is a HAMR drive because it has the laser warning sticker stuck on the front

Below is a picture of an integrated HAMR head including the laser (not the same head used in the drive)





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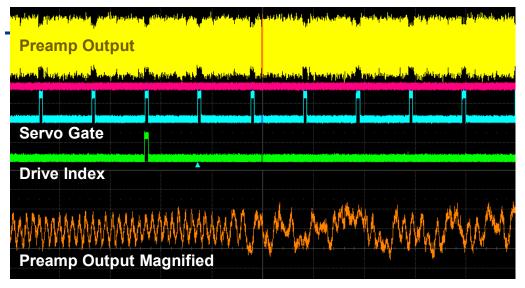
# Scope Capture of HAMR Drive Data

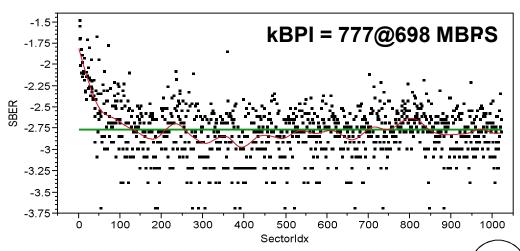
This top figure is a scope capture from a fully functional HAMR drive after writing a full revolution of continuous sectors

The yellow trace shows the signal from the head which has been magnified. The sector preamble and sync mark are clearly visible in the magnified trace



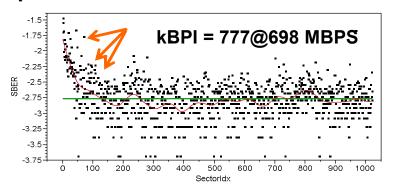
The figure on the bottom shows the sector raw BER for 1011 continuous sectors.

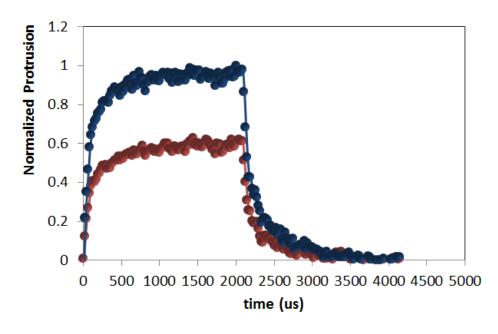


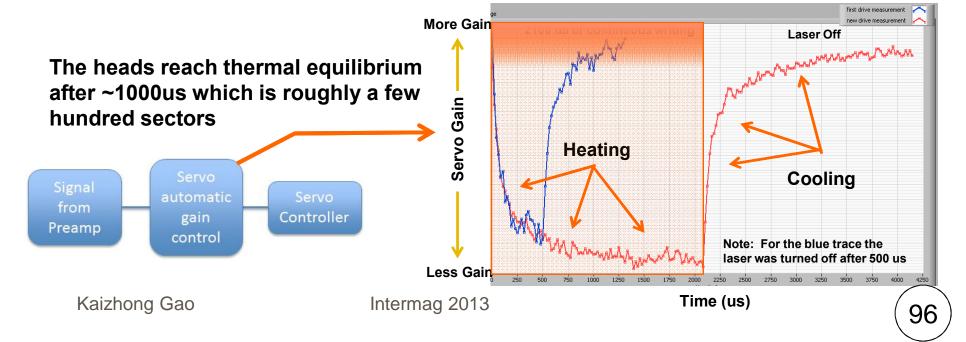


# Full Track BER

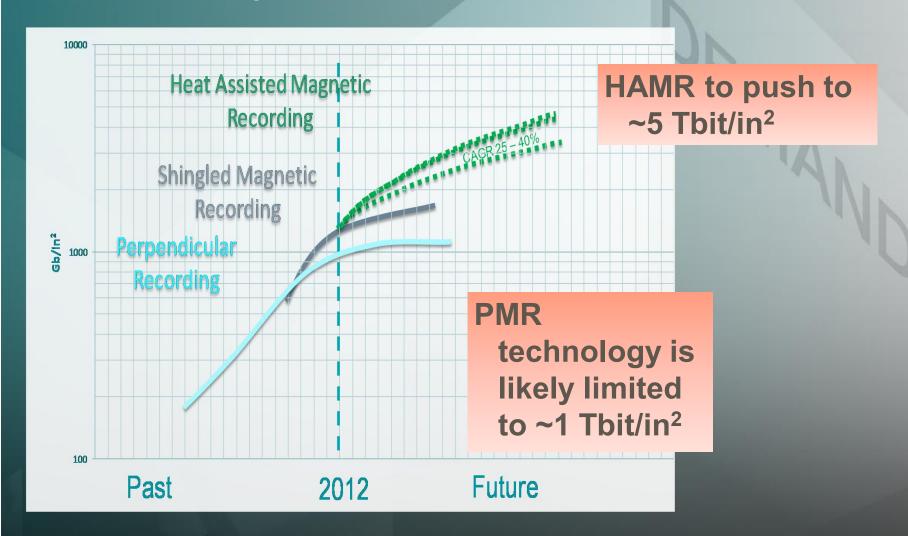
It takes 50 sectors for the BER to reach equilibrium.







# **Areal Density Demonstrations**

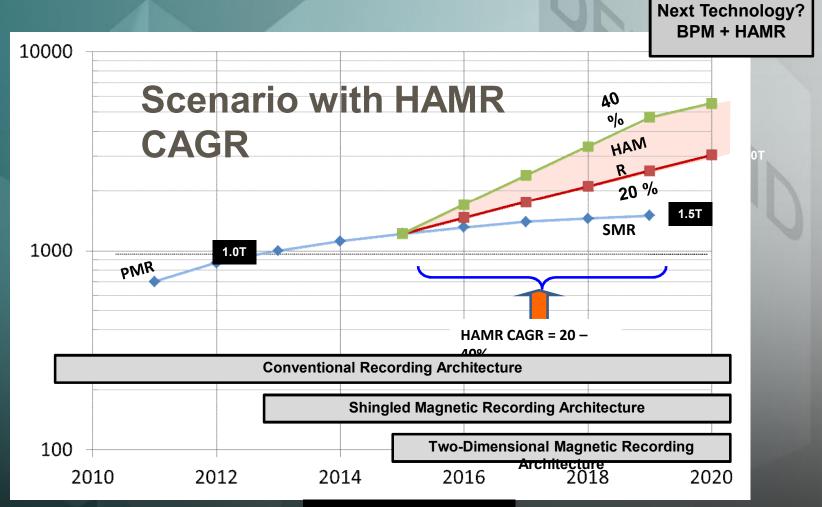


Technology transitions PMR => SMR => HAMR

# **Assumptions**

- PMR areal density growth rate is slowing to < 10% CAGR</li>
- SMR will increase areal density by ~ 40%
- SMR and TDMR architectures will be used to increase capacity in selected markets
- Channel gains will continue at 3% CAGR
- HAMR production starts in 2015 with a 20 40% CAGR
- At current investment levels/technology progress, we can not put MAMR or BPM on the product roadmap before 2020.
- As HAMR approaches its limit, ~ 5 Tbpsi, or if HAMR progress is delayed, alternative technology activities will be increased.
- Technology investments will be committed to ensure continued drive capacity growth.

# **Areal Density Growth Roadmap**



**Production Start Date** 

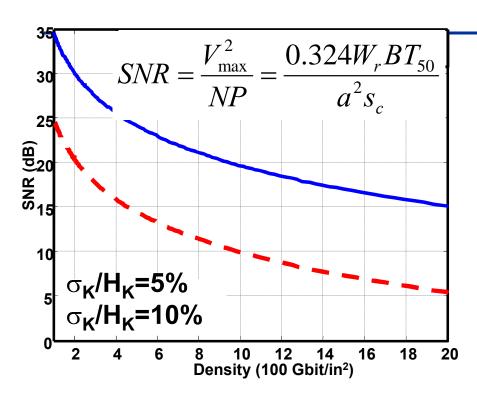
### Early Stage HAMR Challenges (10 Years Work)

- Optical confinement required development of plasmonic near field transducer to provide needed spot size (sub-50nm).
- FePt media as a new recording layer require significant development effort.
- Perpendicular recording set a moving target and extend areal density of HDD at rapid speed beyond longitudinal recording.

### Current Challenges (within next few years)

- Media Distributions\*
  - Distributions much larger than PMR
  - Benefit of large effective gradient in HAMR
- Electronic Noise
  - Lower Mrt and high HMS
- Reliability\*
  - Head, media, HDI due to thermal stress
- Head Media Spacing
  - Larger than the current PMR
  - Media roughness, coating thickness, thermo-mechanical
  - Clearance management
- Efficient light delivery path has added complexity as compare to perpendicular recording

# HAMR Recording, Impact of SFD



 Movie for compare to 10% vs. 30% H<sub>K</sub> distribution taken out.

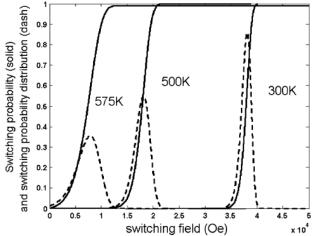
$$\frac{\sigma H_K}{H_K} = 10\% \ vs. (\sigma H_K)/H_K = 30\%$$

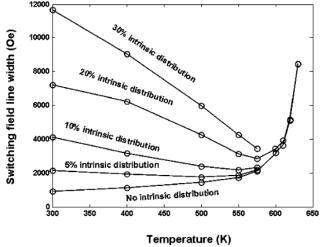
Conventional perpendicular recording will have significant challenge as it approach 1Tb/in<sup>2</sup>, the primary limiting factors is due to SFD, instead of SF (writeability).

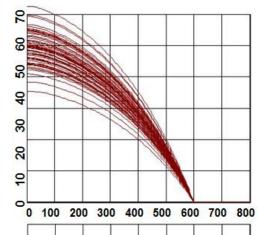
K. Z. Gao and H. N. Bertram, "Transition Jitter ...", IEEE Trans. Magn. vol. 39, no 2, p.704-9, 2003.

**HAMR** still requires low SFD media

#### Switching Field Distribution at Elevated Temperature



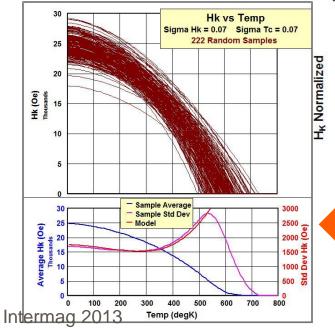


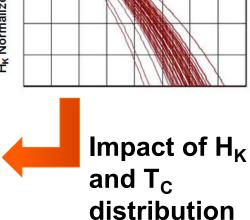


Switching field distribution broadening at elevated

temperature

HAMR has additional SFD contributing factors during recording



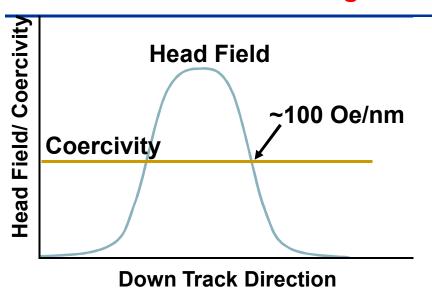


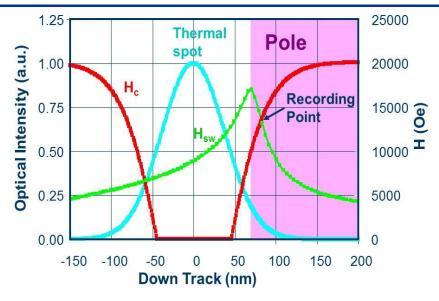
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# HAMR benefit: ultra sharp write gradient

#### **Traditional Recording**

#### **HAMR Recording**





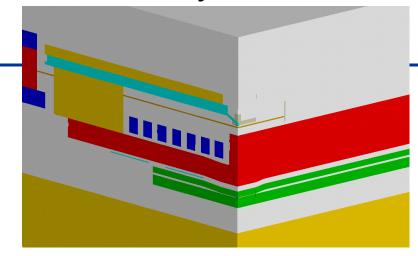
write gradient = 
$$\frac{dH_x}{dx}$$

write gradient = 
$$\frac{dH_x}{dx}$$
 write gradient =  $\frac{dH_x}{dx} - \frac{dH_x}{dT} \frac{dT}{dx}$ 

Large effective write field gradients are advantageous in both cross track and down track directions.

Rausch et al., *IEEE Trans. Magn.* 40 (2004) 137

**HAMR** Reliability



Managing temperatures in the transducer is key.

- The media must reach it's cure temp. 700-800K within 100's of ps.
- Experimental stress tests and modeling indicate that the transducer rapidly degrades at > 500K.

The optical resonant coupling enables temp. rise in the media to be 3X> temp. rise in head.

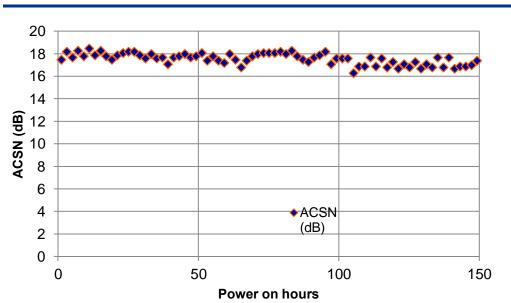
However the extreme localization of the heating source can still lead to localized protrusions that need to be managed.

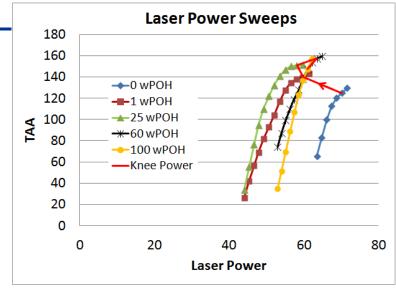
**Protrusion Temp** 

Clearance with respect to close point [Å]

#### Illustration of at least 150 hours continuous writing.

#### Reference SNR after power on writing



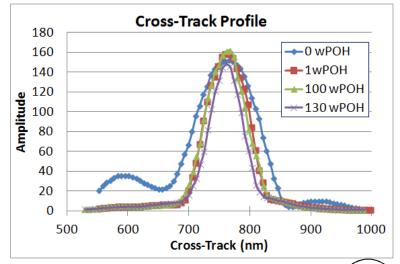


#### **Spinstand measurements:**

Optimal laser power initially drops after first hour of test, track confinement improves, and stabilizes.

Head failed beyond 150 hours.

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# Summaryõ

- PMR has replaced LMR within the past decade:
  - Due to significant reduction of media (SFD) and improved writeability, field gradient
  - After 5X areal density gain conventional PMR areal density slows down
- HAMR have been demonstrated at both spin stand level and in drive
  - After HAMR demo catches PMR in terms of areal density, HDD industry now working on HAMR for products from 1-5Tb/in<sup>2</sup> (ASTC)
  - New component technologies have been developed, such as NFT and FePt.
  - Significant challenges in SFD and recording head reliability are being addressed.
  - With continue growth in storage demand, there is more urgent need to productize HAMR beyond conventional perpendicular recording.
  - HAMR still have many practical challenges needs to be solved before launches as product.

### Successful 2012-2013 for HAMR

#### <2012>

In March Seagate announced a 1.0 TBPSI demonstration of HAMR on spin stand

Later in October, TDK announced a 1.5 TBPSI demonstrated on spin stand

Seagate CEO ran his annual investor relations talk off a HAMR drive in September

#### <2013>

October 2013, Japan Argus HAMR drives were demonstrated in a Win7 computer at CEATEC 2013 Japan

Nov. 2013, Ninbo China
WD demonstrated HAMR enabled 2.5" drive
Y. Peng etc.

Dresden May 5, 2014







#### What's Next?

# challenges

#### ASTC listed:

thermal gradient

sigma grain size

magnetization

sigma Hk

sigma Tc

sigma theta

grain aspect ratio

#### HAMR Media High AD Challenges ASTC

Areal Density (Tb/in²)	2	4		
KTPI	700	1155		
KBPI	2800	3464		
BAR	4	3		
Thermal gradient @ writing (K/nm)	14	18		
Center to center Dp (nm)	7.0	5.1		
Dcore (nm)	6.0	4.3		
σ / mean grain diameter	0.1-0.15	0.1-0.15		
Ms film (emu/cc) (room temperature)	700	800		
Ms core (emu/cc)	875	1000		
Ku (erg/cm^3) (room temperature)	3.50E+07	5.00E+07		
Hk (kOe) (room temperature)	30	100		
т Hk/Hk	5%-10%	5%-10%		
Tc .	<=750	700~750		
o Tc/Tc	2%	2%		
igma theta (deg)	2.0	0.8		
media thickness (nm)	9	8.2		
thickness over grain size	1.29	1.60		
SUL requirement	yes	yes		
jitter (nm)	1.55	1.43		
itter/bit length (%)	17.1%	19.5%		
Grains/bit	6.7	6.2		
Grains/read width	4.0	3.7		

#### Key challenges:

- 1. Thermal gradient
- Sigma grain size
- 3. Magnetization
- 4. Sigma Hk
- Sigma Tc
- 6. Sigmatheta
- 7. grain aspect ratio

D. Weller, G. Parker, O. Mosendz, E. Champion, B. Stipe, X. Wang, T. Klemmer, G. Ju, A. Ajan, "The HAMR Media Technology Roadmap to an Areal Density of 4 To/In?" IEEE Trans Mag 50, 3100108 (2014)

#### IDEMA

## and if you think about HAMR drives

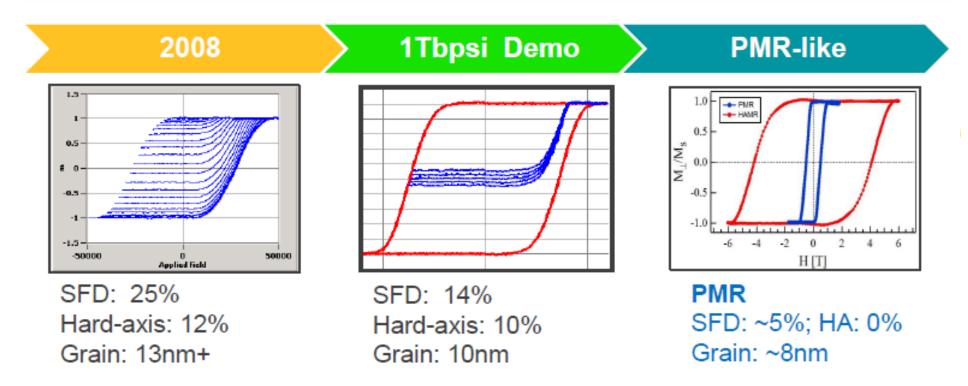
+ laser power requirement

+ mechanical performance

Y. Peng etc.

ASTC=Advanced Storage Technology Center

# Along the time line



- Given the fundamental magnetics, 1T demo would have not been possible without the benefit from HAMR's unique thermal gradient
- Full advantage of HAMR shall be seen when media parameters match PMR's and go beyond

# Materials choices and ultimate limits of magnetic recording

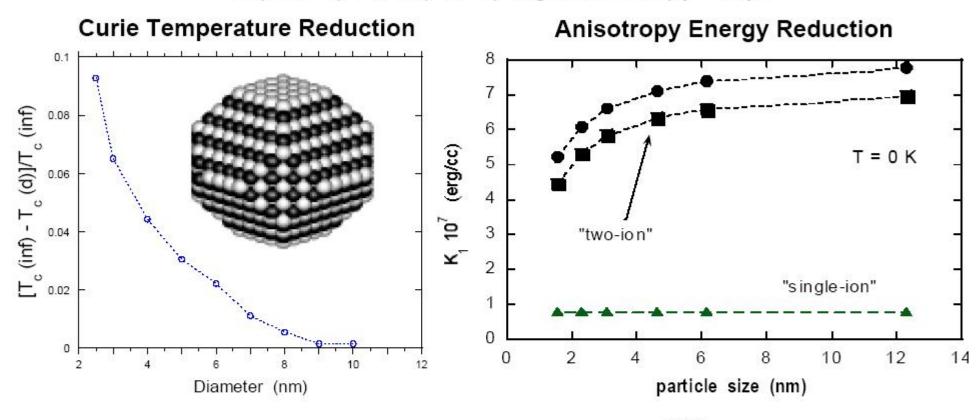
Media Materials Options (Bulk Properties)

						10 m		$\bigcirc$	¶% 7=0/8
alloy system	material	$K_1$	$M_{\rm S}$	$H_K(kOe)$	$T_{C}(K)$	$\mathrm{D_p}^{(a)}$	$D_p^{(b)}$	$D_p^{(c)}$	$D_p^{(d)}$
		$(10^7 \text{erg/cm}^3)$	(emu/cm <sup>3</sup> )			(nm)	(nm)	(nm)	(nm)
	CoCr <sub>20</sub> Pt <sub>15</sub>	0.25	330	15.2		15.5	12.4	15.3	7.8
Co-alloys	Co <sub>3</sub> Pt	2	1100	36.4	1200	6.4	6.9	8.5	4.3
	(CoCr) <sub>3</sub> Pt	0.39	410	19		12.4	10.6	13.2	6.7
	CoPt <sub>3</sub>	0.5	300	33.3	600	9.0	8.6	10.7	5.4
CoX/Pt(Pd)	Co2/Pt9	1	360	55.6	500	6.1	6.7	8.3	4.2
multilayers	Co2/Pd9	0.6	360	33.3	500	8.4	8.2	10.2	5.2
	FePd	1.8	1100	32.7	760	7.3	7.5	9.3	4.7
$L1_0$	FePt	7	1140	122.8	750	2.4	3.6	4.4	2.3
phases	CoPt	4.9	800	122.5	840	2.8	3.9	4.9	2.5
	MnAl	1.7	560	60.7	650	4.9	5.7	7.1	3.6
rare-earth	$Fe_{14}Nd_2B$	4.6	1270	72.4	585	3.4	4.5	5.5	2.8
transition m.	SmCo <sub>5</sub>	20	910	439.6	1000	1.3	2.4	2.9	1.5

 $D_p$ : smallest possible thermally stable magnetic grain core size!

# **Particle Size Effects**

3d(Fe,Co)-5d/4d(Pt/Pd) High Anisotropy Alloys



Surface to volume fraction increases to 20-40% for 3 nm FePt particles (1000 atoms)

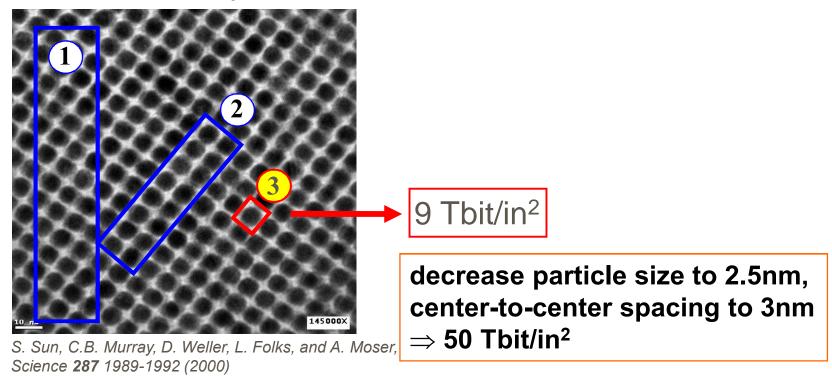
O. Mryasov et.al., Europhy. Lett. 69, 805 (2005)

$$d_{ij}^{(2)} = \frac{k_{Pt}^{(0)}}{[J_{\mu}^{0}]^{2}} \sum_{\mu} J_{i\mu}^{Fe-Pt} J_{j\mu}^{Fe-Pt}$$

Finite size effects due to interactions mediated by induced Pt magnetic moment

# Ultimate size limits of magnetic recording

#### 6nm FePt nanoparticles



- 1 Conventional Granular Media
- 2 Bit Patterned Media
- 3 Single-Grain-Per-Bit Patterned Media

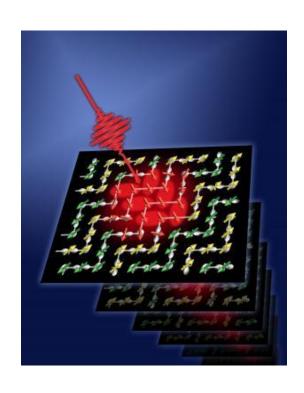
# The speed limit of magnetic recording

Ultrafast pulse - use electron accelerator experiments at Stanford Linear Accelerator C. Back, Science **85** (1999) p864 sample I. Tudosa, Nature **428** (2004) p831 electron t<sub>pulse</sub>= 100 fs t<sub>pulse</sub>= 3 ps 90 µm 90 µm 30 times faster than conventional 1000 times faster than conventional -- switching still works reliably ---- switching is not reliable --

There is a speed limit!

.. but we don't understand why

# The speed limit of magnetic recording

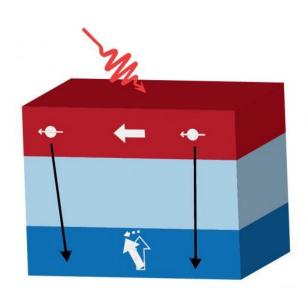


Magnetic structure in a colossal magneto-resistive manganite is switched from antiferromagnetic to ferromagnetic ordering during about 100 femtosecond laser pulse photo-excitation. With time so short and the laser pulses still interacting with magnetic moments, the magnetic switching is driven quantum mechanically -- not thermally. This potentially opens the door to terahertz and faster memory writing/reading speeds.

Ames Laboratory, Iowa State University, and the University of Crete in Greece.

The discovery was reported in the April 4 issue of Nature, potentially opens the door to terahertz (10<sup>12</sup> hertz) and faster memory speeds.

# The speed limit of magnetic recording



The physicists use a special property of electrons, the spin . a kind of internal compass in the electron. Using ultra-fast laser pulses they generate a flow of electrons in a material which all have the same spin. The resulting 'spin current' changes the magnetic properties of the material. "The change in the magnetization is of the order of 100 femtoseconds, which is a factor 1,000 faster than what is possible with today's technology"

More information: 'Ultrafast spin-transfer torque driven by femtosecond-pulsed laser excitation' by A.J. Schellekens, K.C. Kuiper, R.R.J.C. de Wit and B. Koopmans (all of Eindhoven University of Technology) is published online in Nature Communications

# The ultimate limits of magnetic recording

